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INTERNATIONAL STANDARD

IEEE Std 1445™

Digital Test Interchange Format (DTIF)





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Digital Test Interchange Format (DTIF)

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IEEE Std 1445-1998	93/321/FDIS	93/328/RVD

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- withdrawn,
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- amended.

IEEE Standard for Digital Test Interchange Format (DTIF)

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Abstract: The information content and the data formats for the interchange of digital test program data between digital automated test program generators (DATPGs) and automatic test equipment (ATE) for board-level printed circuit assemblies are defined. This information can be broadly grouped into data that defines the following: UUT Model, Stimulus and Response, Fault Dictionary, and Probe.

Keywords: automatic test equipment (ATE), digital automated test program generator (DATPG), digital test interchange format (DTIF), Fault Dictionary data

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IEEE Introduction

[This introduction is not part of IEEE Std 1445-1998, IEEE Standard for Digital Test Interchange Format (DTIF).]

A digital automated test program generator (DATPG) produces test pattern and diagnostic data that can be used for testing printed circuit assemblies on automatic test equipment (ATE). The use of several DATPGs, all with individual output formats, created a need for many unique post-processors to be developed and maintained for the life of the ATE. These post-processors supported the link from specific DATPGs to specific testers. The proliferation of unique formats and post-processors created logistical support problems and therefore identified a need for standardization. A DATPG and ATE independent output data format is required to limit the number of post-processors (one for each ATE) requiring life cycle support. The digital test interchange format (DTIF) was chosen because of its wide use and because it was becoming known in industry as the de facto standard.

This document provides the basis to standardize digital test information for use on ATE. The digital test information consists of the unit under test (UUT) Model information, Stimulus and Response data, Fault Dictionary data, and Probe data.

DTIF is unique from other standards such as IEEE P1450 (Draft 0.95, dated July 1998),¹ Draft Standard Test Interface Language (STIL) for Digital Test Vector Data, and IEEE Std 1029.1-1991, IEEE Standard for Waveform and Vector Exchange Specification (WAVES). STIL is being developed to standardize the output interface of existing computer-aided engineering (CAE) tools with the input interface of ATE for integrated circuit (IC) testing only. WAVES is a hardware descriptive language used for defining stimulus and response, and their associated timing for IC/board-level design. Neither STIL nor WAVES provides for board-level fault diagnostics.

A future revision of this standard will consider the use of the information model.

¹ IEEE P1450 is an IEEE authorized standards project that was not approved by the IEEE-SA Standards Board at the time this publication went to press. For information about obtaining the draft, contact the IEEE.

Digital Test Interchange Format (DTIF)

1. Overview

The digital test interchange format (DTIF) is designed to provide a mechanism for digital test data interchange independent of specific digital automated test program generators (DATPGs) and test systems. The DTIF provides a neutral database for the development and delivery of digital simulation based test program sets (TPSs). DTIF functionally supports the unit under test (UUT) Model, Stimulus and Response, Fault Dictionary, and Probe databases.

1.1 Scope

This standard defines the information content and the data formats for the interchange of digital test program data between DATPGs and automatic test equipment (ATE) for board-level printed circuit assemblies. This information can be broadly grouped into data that defines the following:

- a) UUT Model;
- b) Stimulus and Response;
- c) Fault Dictionary;
- d) Probe.

1.2 Purpose

The purpose of this standard is to provide a standard output format for test data generated by a DATPG. A DATPG produces test patterns and fault diagnostic data for ATE. This data is used in applications such as board-level assemblies where diagnostic data interchange is important.

1.3 Application

This standard is primarily intended for use by digital simulator developers/maintainers and TPS developers/maintainers.

2. References

This standard shall be used in conjunction with the following standards. When the following standards are superseded by an approved revision, the revision shall apply.

ANSI X3.4-1986 (Reaff 1997), Information Systems—Coded Character Sets—7-Bit American National Standard Code for Information Interchange (7-Bit ASCII).¹

IEEE Std 100-1996, IEEE Standard Dictionary of Electrical and Electronics Terms.²

3. Definitions and acronyms

3.1 Definitions

The following definitions are for use with this standard. For other uses and for definitions not contained herein, see IEEE Std 100-1996. Unless otherwise indicated, the ATPG subcommittee formulated all terms defined in this subclause.

3.1.1 burst: A set of stimulus patterns and related unit under test (UUT) responses that are set up, applied, and read as a group. A test program may employ more than one burst to provide the stimuli and responses necessary to test the UUT.

3.1.2 channel: The tester electronics associated with a digital input/output (I/O) pin that either drives or senses a particular node on the unit under test (UUT).

3.1.3 circuit simulator: A software program that predicts a circuit's response to a given stimulus.

3.1.4 digital automatic test program generator (DATPG): A program, often based on simulation, that aids in the development of test patterns and diagnostic information from the model of a unit under test (UUT).

3.1.5 dynamic patterns: A set of controlled, time-variant patterns within a time interval.

3.1.6 edge: A logic state transition that is considered instantaneous for a given pattern in the simulation process.

3.1.7 end-to-end test: A test sequence to establish pass (functioning properly) or fail (not functioning properly) conditions. *Syn:* **go/nogo test.**

3.1.8 fault set: A group of one or more faults with the same fault signature.

3.1.9 fault signature: A set of unique primary output patterns in which the fault will produce a response different from the good machine response.

3.1.10 fault title: A two-part description that includes a node name and a fault type [i.e., <U5>6 SA1 (component: U5, pin: 6, fault type: Stuck at 1)].

3.1.11 go/nogo test: *See:* **end-to-end test.**

¹ANSI publications are available from the Sales Department, American National Standards Institute, 11 West 42nd Street, 13th Floor, New York, NY 10036, USA (<http://www.ansi.org/>).

²IEEE publications are available from the Institute of Electrical and Electronics Engineers, 445 Hoes Lane, P.O. Box 1331, Piscataway, NJ 08855-1331, USA (<http://www.standards.ieee.org/>).

3.1.12 logic state: The representation a simulator uses to describe the state of a circuit during digital logic simulation. There are four types of logic states that exist in a typical simulator: 0, 1, Z, and X.

3.1.13 main model: The top-level unit under test (UUT) model description that includes a list of component packages and a netlist.

3.1.14 netlist: A point-to-point description of the interconnections between individual components in a circuit.

3.1.15 patterns: A set of unit under test (UUT) stimulus and expected response states. A pattern contains one unit of logic state (0, 1, X, Z) data for each UUT input and each UUT output pin.

3.1.16 phase: The time within a timing cycle when a primary input is in transition between logic states.

3.1.17 primary input (PI): A node in a circuit in which the tester can apply stimulus.

3.1.18 primary output (PO): A node in a circuit in which the tester can observe a response.

3.1.19 primary output patterns (POPAT): A set of unique responses at the node in which a fault or a group of faults are detected.

3.1.20 probe: A tester instrument used to observe the state of a node.

3.1.21 probeable node: Any node that is physically accessible to a tester probe.

3.1.22 probe window: The period of time during a pattern when a probe can capture activity on a node.

3.1.23 probing: A fault diagnostic technique that incorporates the use of a portable device (hand-held or robotic) to monitor or capture unit under test (UUT) response data. The location of the probe placement is determined by the circuit response and the circuit topology.

3.1.24 simulation time unit (STU): A fixed unit of time that is utilized during simulation for evaluation of data.

3.1.25 skew: The timing ambiguity associated with the occurrence of an automatic test equipment (ATE) Input/Output (I/O) event that is due to the physical limitations of the ATE digital driver and detector electronics.

3.1.26 static patterns: A set of controlled, time-invariant patterns.

3.1.27 stimulus: The logic states within a pattern that drives a circuit model in simulation, or a unit under test (UUT) on an automatic test equipment (ATE).

3.1.28 strobe: To record or measure the state of a particular node at an instant in time. Strobing will have a skew associated with it.

3.1.29 threshold voltage: The minimum voltage considered to be a high state or the maximum voltage considered to be a low state.

3.1.30 timing ambiguity: The period of time in a nodal transition during which the state of the node cannot be guaranteed.

3.1.31 timing generator: The function in the automatic test equipment (ATE) that stores and produces timing sets, or its analogous construct in the simulation process.

3.1.32 timing set (TSET): An automatic test equipment (ATE) timing-cycle during which stimuli are applied and unit under test (UUT) responses are measured. A timing set includes the specification of the pattern period, UUT input pin groupings that will transition at a specific time within a pattern, and UUT output pin groupings that share the same window.

3.1.33 trace: A diagnostic fault isolation program that uses a probe on a tester.

3.1.34 window: The period of time during a pattern cycle when a primary output is actively monitored by an automatic test equipment (ATE) channel.

3.2 Acronyms

ASCII	American Standards Code for Information Interchange
ATE	automatic test equipment
CAE	computer-aided engineering
DATPG	digital automated test program generator
DTIF	digital test interchange format
IC	integrated circuit
I/O	input/output
FLAP	fault set last analyzed POPAT
PI	primary input
PO	primary output
POPAT	primary output patterns
STU	simulation time unit
TP	test program
TPS	test program set
TSET	timing set
UUT	unit under test

4. Data organization overview of the DTIF standard environment

Digital circuit simulators for test, measurement, and diagnostic equipment provide an effective way to predict UUT behavior (good and bad) during test on an ATE. Results of the simulation can be used to generate the data necessary to produce a test program for the digital UUT. This standard defines the data generally available from test simulation and describes its structure for use in generating digital test programs for ATE.

Digital simulators typically provide data on the UUT Model, Stimulus and Response, Fault Dictionary, and Probe. Figure 1 shows a total of 39 American Standard Code for Information Interchange (ASCII) files, which includes a Header File and 38 data files. The Header File provides summary information and a listing of the total DTIF file set generated by a simulator for a given digital circuit. The 38 data files are organized into four functional groups. Each group portrays the functional role as it relates to UUT testing. They are

- a) UUT Model Group (15 data files);
- b) Stimulus and Response Group (9 data files);
- c) Fault Dictionary Group (6 data files);
- d) Probe Group (8 data files).

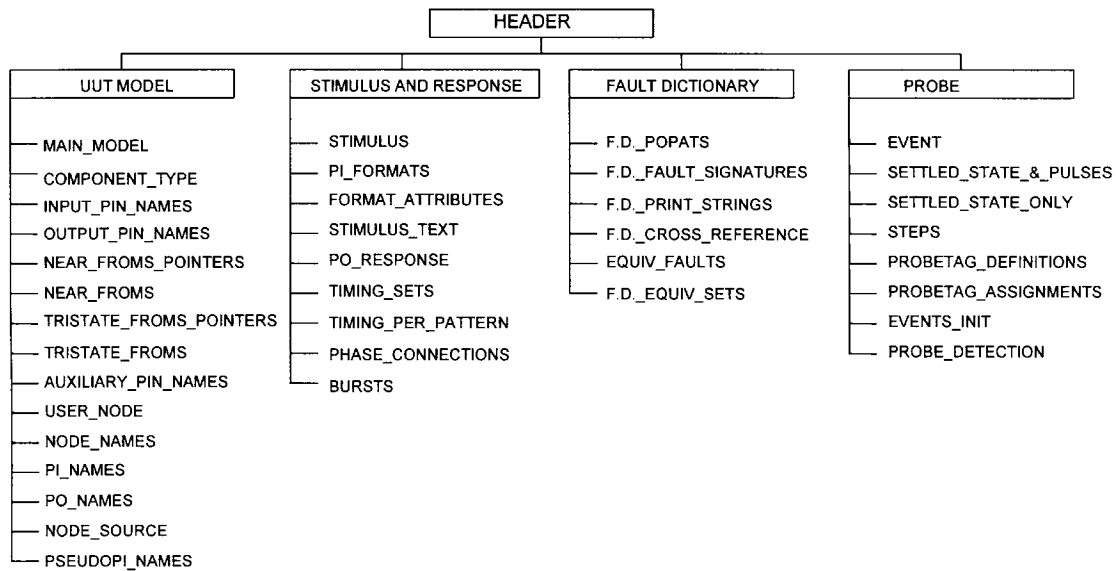


Figure 1—DTIF data files

4.1 UUT Model Group

The UUT Model Group consists of 15 data files that define the UUT Model topology. These files are used to identify the UUT/ATE interface pins, identify all the devices on the UUT, define the interconnections between devices and the structural dependencies between the inputs and outputs of a device, and to identify signal driving sources and their fan-out. They also define functional dependencies of device outputs to their inputs. The information contained in the UUT Model Group is used to develop both end-to-end and diagnostic test programs.

4.2 Stimulus and Response Group

The Stimulus and Response Group consists of 9 files. Data in these files are used to define the logic value of applied stimulus and observed good circuit response. They identify the timing of stimulus edge transitions within a pattern and the period of valid output responses within a pattern. Another function of the Stimulus and Response files is to identify groups of UUT pins with the same stimulus and response timing characteristics.

4.3 Fault Dictionary Group

The Fault Dictionary Group contains a total of 6 files. Data in these files are used on ATE to diagnose UUT failures with the fault dictionary technique. With fault dictionaries, failing responses from the UUT, captured by the ATE, are compared with the fault signatures generated in the fault simulation process and stored in ATE memory. This group identifies all faults and groups of equivalent faults, fault signatures for all detected faults, and the faults grouped within a specific fault set.

4.4 Probe Group

The Probe Group consists of a total of 8 files. They contain all the necessary information to generate probe diagnostics for an ATE. This information includes a complete history of the logic state activity and signal

timing at every device pin on the UUT, and data that assists in specifying probe window placement and timing.

5. File specifications

In this clause, the formats for each of the 39 files specified by the DTIF standard are defined. Each file consists of two or more records. One record is a line up to 80 bytes long. The records are of varying size. When writing files, trailing blanks are truncated from the records to reduce the size of the resultant file. The first record of each file shall be a Header record. All data shall be in ASCII format. The DTIF file names are not case sensitive.

All alphanumeric (character) fields are left justified. They are identified in every file description by the character 'A', and the size of each field is defined by a numeric value immediately following the character 'A.' For example, (A4) describes a four-character alphanumeric field.

All integer fields are right justified. They are identified in every file description by the character 'I,' and the size of each field is defined by an integer value immediately following the character 'I.' For example, (I6) describes a six-character integer field.

Should it be required to repeat a particular field within the file description, a multiplier may be used. For example, 5(A16) describe a sixteen-character alphanumeric field that is repeated five times.

The following pages describe the DTIF file data specifications. Each subclause includes an example specific to that file to aid in understanding. The data itself has no relationship to any other DTIF file example.

5.1 HEADER file

File type name: HEADER

File name: header.tap

File number: 1

Description: This file provides a configuration accounting for all of the files that comprise the complete data set for a particular UUT.

Format:

Line 1:	Columns 1:24 - DTIF file type name (A24)
	Columns 25:27 - DTIF file number (I3)
	Columns 28:31 - File version number (optional value)(I4)
	Columns 32:55 - UUT name (A24)
	Columns 56:72 - File creation date and time (A17) (note 1)
	Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)
Line 2:	Columns 1:24 - Model compilation date and time (A24) (note 1)
Line 3:	Columns 1:10 - Number of primary inputs (I10)
Line 4:	Columns 1:10 - Number of primary outputs (I10)
Line 5:	Columns 1:10 - Number of patterns (I10)
Line 6:	Columns 1:10 - Number of packages (I10)
Line 7:	Columns 1:10 - Number of main model (user) defined components (I10)
Line 8:	Columns 1:10 - Number of component types (I10)
Line 9:	Not used
Line 10:	Not used
Line 11:	Columns 1:10 - Number of wired nets (I10)
Line 12:	Columns 1:10 - Number of user nodes (I10)
Line 13:	Columns 1:10 - Highest user node number (I10) (note 2)
Line 14:	Columns 1:10 - Number of DTIF files generated (I10)
Line 15:	Columns 1:10 - Number of original faults considered (I10)
Line 16:	Columns 1:10 - Number of final definite detects (I10)
Line 17:	Columns 1:10 - Number of final possible detects (I10)
Line 18:	Columns 1:10 - Pattern detection limit (maximum # of times a fault is detected) (I10)
Line 19-29:	Not used.
Line 30 to N:	Columns 1:24 - DTIF file type name(A24) (note 3)
	Columns 25:27 - DTIF file type number (I3)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—The number of user nodes and the highest user node number may not be one and the same. There may be gaps.

3—One line is used for each file type.

Example:

```

HEADER          1    2UnitUnderTestAA      10-JAN-2000 12:00
1-JAN-2000
  10
   5
  15
  20
  20
   8

   7
  75
 115
  39
 350
 225
   50
  
```


HEADER	1
STIMULUS	2
PO_RESPONSE	3
PI_NAMES	4
PO_NAMES	5
MAIN_MODEL	6
COMPONENT_TYPE	7
USER_NODE	8
INPUT_PIN_NAMES	9
OUTPUT_PIN_NAMES	10
NEAR_FROMS_POINTERS	11
NEAR_FROMS	12
EVENT	13
SETTLED_STATE_ONLY	14
SETTLED_STATE_&_PULSES	15
NODE_SOURCE	16
STEPS	17
F.D._POPATS	18
F.D._FAULT_SIGNATURES	19
F.D._PRINT_STRINGS	20
TRISTATE_FROMS_POINTERS	21
TRISTATE_FROMS	22
PSEUDOPI_NAMES	23
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STIMULUS_TEXT	34
NODE_NAMES	35
EVENTS_INIT	36
EQUIV_FAULTS	37
PROBE_DETECTION	38
F.D._EQUIV_SETS	39

5.2 STIMULUS file

File type name: STIMULUS

File name: stimulus.tap

File number: 2

Description: The STIMULUS file contains all the input pin states required to test a UUT. Stimuli are limited to four states. They are unknown (X), high impedance (Z), low (0), and high (1). These logic states are represented by numeric characters and they are: 1=X, 2=Z, 3=Low, and 4=High. Pseudo input pins that have permanently assigned states are used as sources for fixed logic states (i.e., gnd) and are defined in the PSEUDOPI_NAMES file.

When a TSETS file is assigned, patterns in this file represent a dynamic pattern set. Without the TSETS file, they would represent a static stimulus set.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1:10 - Number of primary inputs (I10)
Columns 11:20 - Number of test patterns (I10)
Columns 21:30 - Number of lines per pattern (I10)
Columns 31:40 - Number of lines containing pattern information (I10)

Line 3 to N: Columns 1:80 - Stimulus data (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—Stimulus data is stored using the input pin order listed in PI_NAMES file. A new line is required for every pattern; however, a pattern greater than 80 pins would continue on the next line.

Example:

```
STIMULUS      2  2UnitUnderTestAB      10-JAN-2000 12:00
      86      4      2      8
34343431243212111343323212232343212112213433332232132322122322122223334223223243
223432
31232221111134332321223234323323433211122234322121244323112343321232123322341122
343343
44343332322111212443222112122221331333422211232342123442231233312443323211123333
321122
43444332211122123344323222212211233342223344433211212332332332113212122333233322
233233
```

5.3 PO_RESPONSE file

File type name: PO_RESPONSE

File name: response.tap

File number: 3

Description: The PO_RESPONSE file contains all of the expected output pin response states required to compare to that of the UUT. Responses are limited to four states. They are unknown (X), high impedance (Z), low (0), and high (1). These logic states are represented by numeric characters rather than alphabetic characters, and they are: 1=X, 2=Z, 3=Low, and 4=High.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1:10 - Number of primary outputs (I10)
 Columns 11:20 - Number of patterns (I10)
 Columns 21:30 - Number of lines per pattern (I10)
 Columns 31:40 - Number of lines containing pattern information (I10)

Line 3 to N: Columns 1:80 - Response data (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].
 2—Response data is stored using the output pin order listed in PO_NAMES file. A new line is required for every pattern; however, a pattern greater than 80 pins would continue on the next line.

Example:

```
PO_RESPONSE      3      5      3      2UnitUnderTestAC      10-JAN-2000 12:00
      3      5      1      5
341
413
334
443
344
```

5.4 PI_NAMES file

File type name: PI_NAMES

File name: pinames.tap

File number: 4

Description: This file identifies each primary input pin by name and by user node number. The name of the primary input pin for each user node is typically the schematic or etched board name. Each primary input pin must have a name. This name is used for I/O connection and in probe algorithms. Primary bus I/O pins are considered in both the PI_NAMES file and the PO_NAMES file. All primary input pins and output pins not connected to any other I/O pin are in connectivity group 0. Bus pins or I/O pins are assigned a unique connectivity group number starting with 1. Identical connectivity group numbers are assigned to I/O pins when they appear in both the PO_NAMES file and the PI_NAMES file. In addition, there is no requirement that the name of the PI and PO be the same.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error in
 file generation (A5)

Line 2: Columns 1:10 - Total number of primary input pins (I10)
 Columns 11:16 - Total number of I/O connectivity groups
 (I6)(note 2)

Line 3 to N: Columns 1:24 - Primary input name (A24) (note 3)
 Columns 25:29 - User node number (I5)
 Columns 30:34 - Connectivity group number (I5)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—This number is one larger than the highest numbered group since there is a pseudo group 0 representing all PIs and POs that are not connected to any other.

3—The information for each primary input pin is contained on its own line.

Example:

PI_NAMES	6	3	4	2UnitUnderTestAD	10-JAN-2000 12:00
WR			1	0	
RESET			2	0	
AD_LOAD			3	0	
AD_CLK			4	0	
DATA2			5	1	
DATA1			6	2	

5.5 PO_NAMES file

File type name: PO_NAMES

File name: ponames.tap

File number: 5

Description: This file identifies each primary output pin by name and by user node number. The name of the primary output pin for each user node is typically the schematic or etched board name. Each primary output pin must have a name. This name is used for I/O connection and in probe algorithms. User node numbers are sequentially assigned by a model compiler. Primary bus I/O pins are considered in both the PI_NAMES file and the PO_NAMES file. All primary input pins and output pins not connected to any other I/O pin are in connectivity group 0. Bus pins or I/O pins are assigned a connectivity group number starting with 1. Identical connectivity group numbers are assigned to I/O pins when they appear in both the PI_NAMES file and the PO_NAMES file. In addition, there is no requirement that the name of the PI and PO be the same.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1:10 - Total number of primary output pins (I10)
Columns 11:16 - Total number of I/O connectivity groups (I6) (note 2)

Line 3 to N: Columns 1:24 - Primary output name (A24) (note 3)
Columns 25:29 - User node number (I5)
Columns 30:34 - Connectivity group number (I5)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—This number is one larger than the highest numbered group, since there is a pseudo group 0 representing all PIs and POs that are not connected to any other.

3—The information for each primary output pin is contained on its own line.

Example:

PO_NAMES	4	5	5	2UnitUnderTestAE	10-JAN-2000 12:00
DATA4			100	1	
DATA3			101	2	
DATA2			102	3	
DATA1			103	4	

5.6 MAIN_MODEL file

File type name: MAIN_MODEL

File name: mainmodel.tap

File number: 6

Description: The Main Model file is a description of the UUT that is simulated and contains several major elements. They are component types, component pins, package numbers, user node numbers, and user node names. A component type and its pins are defined once for each component. When used in the main model of a UUT, the components are assigned unique package names as well as package numbers to distinguish their multiple usage in the UUT main model. Each connection from package pin to package pin(s) must have a unique user node number, and can optionally have a user node name. The combination of package names, component pins, and user node numbers completely defines the schematic interconnection of the UUT model.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1:10 - Number of circuit packages(I10) (note 2)

Line 3 to N: Columns 1:24 - The package name (A24)
Columns 25:28 - The package type number (I4) (note 3)
Columns 29:32 - Number of inputs on the package (I4)
Columns 33:36 - Number of outputs on the package (I4)
Columns 37:42 - Index for the first input pin in the USER_NODE file (I6) (note 4)
Columns 43:48 - Index for the first output pin in the USER_NODE file (I6) (note 4)
Columns 49:58 - User component number of this package (I10)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—This number includes wired nets, Z-components, and all probeable components on the UUT.

3—This number is an index into the COMPONENT_TYPE file.

4—‘Index’ means ‘index into the relevant section of the USER_NODE file’s body’ starting from 1.

Example:

MAIN_MODEL	6	2	UnitUnderTestAF	10-JAN-2000	12:00
U1	1	2	1	1	3
U2	2	1	1	4	5
U3	2	1	1	6	7
R1	5	1	1	8	9
R2	5	1	1	10	11
R3	5	1	1	12	13

5.7 COMPONENT_TYPE file

File type name: COMPONENT_TYPE

File name: types.tap

File number: 7

Description: This file sequentially lists every component type by name, the corresponding number of input and output pins, and pointers to where those pins may be found in other DTIF files in the set.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1:10 - Number of component types (I10) (note 2)

Line 3 to N: Columns 1:24 - Component type name (A24)
 Columns 25:28 - Number of inputs for that component type (I4)
 Columns 29:32 - Number of outputs for the component type (I4)
 Columns 33:38 - Index of the first input pin name in the INPUT_PIN_NAMES file (I6) (note 3)
 Columns 39:44 - Index of the first output pin name in the OUTPUT_PIN_NAMES file (I6) (note 3)
 Columns 45:50 - Line number of the first auxiliary pin in the AUXILIARY_PIN_NAMES file (I6) (note 4)
 Column 51 - Either a 'W' for wired net component or blank for all others (A1)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—This number includes wired nets, Z-components, and all probeable components on the UUT.

3—'Index' means 'index into the relevant section of the USER NODE file's body' starting from 1.

4—This is the line where the ground and power pin names are given, not counting the first two lines in the file which are the header-type lines, thus an index value of 1 refers to the third actual line in the AUXILIARY_PIN_NAMES file.

Example:

COMPONENT_TYPE	7	2UnitUnderTestAG				10-JAN-2000 12:00
4						
SN74LS32	8	4	1	1	1	
8216	6	8	9	5	2	
PULLUP	1	1	15	13	3	
WN	3	1	16	14	4W	

5.8 USER_NODE file

File type name: USER_NODE

File name: usernodes.tap

File number: 8

Description: This file sequentially lists the user node numbers assigned to each package found in the MAIN_MODEL. The order is to first list all input pins found in the INPUT_PIN_NAMES file followed by all output pins found in the OUTPUT_PIN_NAMES file for each package in ascending order (package 1, package 2, etc.). If wired nets are used in the UUT, there will be more user nodes than physical nodes to accommodate the bidirectional workaround associated with wired nets. The USER_NODE file used in conjunction with the MAIN_MODEL file represents a netlist for the circuit.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1:10 - The number of unique user nodes in the circuit (I10)
Columns 11:20 - Number of lines used to hold all of the user nodes (I10)

Line 3 to N: Columns 1:80 - User node numbers (8(I10))

NOTE

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

Example:

USER_NODE	8	2UnitUnderTestAH	10-JAN-2000	12:00
25	4			
3	15	16	17	18
5	22	23	24	1
23	24	25	4	10
6	7	14	15	16
				17
				18
				19
				20
				21
				22
				12
				13

5.9 INPUT_PIN_NAMES file

File type name: INPUT_PIN_NAMES

File name: inputpins.tap

File number: 9

Description: This file provides a list of input pin names for every component as listed in the COMPONENT_TYPE file. The input pin names are arranged in the same order that the input pins are defined.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1:10 - Number of input pin names in the circuit (I10)
 Columns 11:20 - Number of lines that contain pin names (I10)

Line 3 to N: Columns 1:80 - Input pin names (5(A16))

NOTE

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

Example:

INPUT_PIN_NAMES	9	2UnitUnderTestAI	10-JAN-2000	12:00
17	4			
1		2	3	1
1		1	2	3
5		8	9	1
4		7		

5.10 OUTPUT_PIN_NAMES file

File type name: OUTPUT_PIN_NAMES

File name: outputpin.tap

File number: 10

Description: This file provides a list of output pin names for every component as listed in the COMPONENT_TYPE file. They are arranged in the same order that the output pins are defined.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an
 error in file generation (A5)

Line 2: Columns 1:10 - Number of output pin names in the circuit (I10)
 Columns 11:20 - Number of lines that contain pin names (I10)

Line 3 to N: Columns 1:80 - Output Pin Names (5(A16))

NOTE

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

Example:

OUTPUT_PIN_NAMES	10	2UnitUnderTestAJ	10-JAN-2000	12:00
14	3			
4		5	6	8
3		6	8	11
4		6	4	5

5.11 NEAR_FROMS_POINTERS file

File type name: NEAR_FROMS_POINTERS

File name: nerfrmptr.tap

File number: 11

Description: NEAR_FROMS are inputs of a device which are associated with an output of that device such that if the output ever fails, and all the NEAR_FROMS of that output are good, then it is the device itself that is bad. Each device output pin has one NEAR_FROMS pointer and uses the same order as in the OUTPUT_PIN_NAMES file. The data in NEAR_FROMS_POINTERS defines a NEAR_FROMS packet and is structured as groups of two integers, where the first integer indicates the number of NEAR_FROMS in the packet associated with the device's output pin, and the second integer is the index into the NEAR_FROMS file pointing to the first NEAR_FROMS in the packet.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2 to N: Columns 1:80 - NEAR_FROMS pointer packages (8(I4,I6)) (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—Each pointer consists of two integers. The first integer (4 columns) is the number of NEAR_FROMS associated with the packet's output pin, and the second integer (6 columns) is an index into the NEAR_FROMS file pointing to the first NEAR_FROMS.

Example:

NEAR_FROMS_POINTERS					11	2UnitUnderTestAK					10-JAN-2000 12:00				
1	1	2	2	3	4	4	7	2	11	4	13	1	14	3	17
2	20	1	22	3	23	5	26	8	31	2	34	3	36	2	39
4	41	2	45	1	47	3	48	5	51						

5.12 NEAR_FROMS file

File type name: NEAR_FROMS

File name: nearfroms.tap

File number: 12

Description: NEAR_FROMS are inputs of a device which are associated with an output of that device such that if the output ever fails, and all the NEAR_FROMS of that output are good, then it is the device itself that is bad. NEAR_FROMS may include unbuffered outputs.

The integers in this file are organized in packets, the size of which is defined by the NEAR_FROMS_POINTERS file. For each packet, the NEAR_FROMS integers in each packet are an index into the INPUT_PIN_NAMES (for positive integers) and OUTPUT_PIN_NAMES (for negative integers) files. Since every NEAR_FROMS packet is associated with a specific device output, the NEAR_FROMS for the output specify the device inputs that would be probed to determine the location of the failure.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2 to N: Columns 1:80 - NEAR_FROMS codes (20(I4)) (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—The NEAR_FROMS codes are as follows:

+N → N is a pointer into the INPUT_PIN_NAMES file. This pointer assumes that the starting position is the pointer from the COMPONENT_TYPE file minus 1.

–N → N is a pointer into the OUTPUT_PIN_NAMES file. This pointer assumes that the starting position is the pointer from the COMPONENT_TYPE file minus 1.

Example:

NEAR_FROMS										12 2UnitUnderTestAL										10-JAN-2000 12:00																	
1	-1	1	-2	-1	1	-3	-2	-1	1	-4	-3	-2	-1	1	-5	-4	-3	-2	-1																		
1	-6	-5	-4	-3	-2	-1	1	-7	-6	-5	-4	-3	-2	-1	1	-8	-7	-6	-5																		
-4	-3	-2	-1	1	-9	-8	-7	-6	-5	-4	-3	-2	-1	1	1	2	3	4	5																		
6	7	8	1	2	3	4	5	6	7	8	1	2	3	4	5	6	1	2	3																		
4	5	6	7	8	6	-5	5	1	6	-6	5	2	6	-7	5	3	6	-8	5																		
4	5	6	1	5	6	2	5	6	3	5	6	4	1	2	3	4	5	6	7																		
8	9	10	11	12	1	2	3	4	5	6	7	8	9	10	11	12	1	2	3																		
4	5	6	7	8	9	10	11	12	1	2	3	4	5	6	7	8	9	10	11																		
12	2	1	3	8	7	9	2	1	4	8	7	9	3	-1	2	1	5	8	7																		
9	3	-1	4	-2	2	1	6	8	7	9	5	-3	4	-2	3	-1	9	1	2																		
3	-1	4	-2	5	-3	6	-4	8	7	1	1	2	3																								

5.13 EVENT file

File type name: EVENT

File name: events.tap

File number: 13

Description: This file presents every logical event which the simulator predicts at every node in the UUT model for each pattern. The fidelity of this file is dependent on the timing resolution specified on line 2.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1:10 - Timing resolution value(I10) (note 2)
Columns 11:14 - Unit of time (I4) (note 2)

Line 3 to N: Columns 1:80 - Contiguous stream of events data (note 3)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—The timing resolution value is a positive integer, that in conjunction with the units of time, represents the Simulation Time Unit (STU). The unit of time is the exponent, base 10, required to calculate the given time unit starting from seconds. If the resolution is 5 and the units of time is –9, the STU is 5 nanoseconds.

3—An event is composed of a two-part data grouping consisting of an integer followed by an alphanumeric operational code (op code), which determines the meaning of the integer value. The integer value represents either time in STU, node number, or a pattern number depending on the op code it precedes. Time values are interpreted as either delta time from the last event or absolute time from the beginning of the pattern depending upon the op code. If the integer value is missing, event time is assumed to be the same as the most recent time value within the pattern. The single-character op codes are as follows:

<u>op code</u>	<u>Meaning</u>
@	Absolute time relative to start of a pattern
A	A relative (delta) time field; specifying the minimum time at which the nodal event might occur. The specified nodes are in a stable state prior to this point in time.
B	A relative (delta) time field; specifying the minimum time at which the nodal event might occur. All of the specified nodes are in an unstable state prior to this point in time.
C	A relative (delta) time field; specifying the maximum time at which the nodal event might occur. These specified nodes are in a stable state after this point in time.
D	A relative (delta) time field; specifying the maximum time at which the nodal event might occur. All of these specified nodes are in an unstable state after this point in time.
E	User node number that just went 'low' or '0'
F	Unused
G	Unused
H	User node number that just went 'high' or '1'
I	Unused
J	Unused
K	User node number that just went to 'Z' or high impedance
L	Unused
M	Unused
N	User node number that just went to 'X' or unknown
O	Unused
P	End of pattern
Q	End of Burst
R	End-of-file (This should never be preceded by an integer.)

Example:

```
EVENT          13      2UnitUnderTestAM          10-JAN-2000 12:00
      1 -12
11000A2H5H9H10H11H12H13H14H15H16H17H18HC2H5H9H10H11H12H13H14H14H16H17H18H6667A51
E64E2242A48H3158A61H2933C51E64E7000C48H7567A73K74K75K76K433C61H35000C73K74K75K76
K24000A3H7HC3H7H50000A8HC8H50000A8EC8E200000A19H20H21H22HC19H20H21H22H10A100H101
H102H103HC100H101H102H103H12030A69N70N71N72N17970C69N70N71N72N69990A1H4H6HC1H4H6
H6667A33H63E5400A62H1263A34HC33H1670C63E5000A35H6670A36HC34H2897A77K78K79K80K10A
104N105N106N107N423C62H3330A37H6670A38HC35H6670A39H6660A40HC36H6670A41H5000C77K7
8K79K80K10C104N105N106N107N1660A42HC37H2239A47H4267A43H4267A44H2400A57E2A69N70N7
1N72NC69N70N71N72N10A104N105N106N107NC104N105N106N107N145C38H4757A65K66K67K68K37
19A69K70K71K72K10A104K105K106K107K4844C39H13370C40H13300C41H13300C42H8700C47H150
00C43H15000C44H57E35000C65K66K67K68K69K70K71K72K10C104K105K106K107K242990A19K20K
21K22KC19K20K21K22K1000000@1P100000A3EC3E14290A81E82E83E84E86E87E88E89E91E92E93E
94E3710A85E90E95E10000C81E82E83E84E86E87E88E89E91E92E93E94E4000C85E90E95E18000A8
HC8H50000A8EC8E50000A3HC3H150000A19H20H21H22HC19H20H21H22H550000A19K20K21K22KC19
K20K21K22K1000000@2P1QR
```

5.14 SETTLED_STATE_ONLY file

File type name: SETTLED_STATE_ONLY

File name: setldonly.tap

File number: 14

Description: This file is an incremental representation of the settled state of each node in the circuit at the end of each pattern, assuming that there is always sufficient time for all nodes to settle to one of the four basic states (X, Z, 0, and 1). Only those nodes that changed state for each new pattern are reported.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error in
 file generation (A5)

Line 2 to N: Columns 1:80 - Contains the final state of the node (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—Only those nodes that changed state are reported. The data is represented as a series of op codes followed by integer fields. Leading blanks are suppressed. The op codes are as follows:

<u>op code</u>	<u>Meaning</u>
1	Node settled to 'X' state
2	Node settled to 'Z' state
3	Node settled to '0' state
4	Node settled to '1' state
5	Not Used
6	Not Used
7	Not Used
8	End of pattern
9	Start of burst marker
10	End of burst marker
11	End of event file
*(asterisk)	The next number is an op code
. (period)	The next number is a count field, showing the number of user nodes that follow the count field
(space)	The next number is a user node number

Example:

```
SETTLED_STATE_ONLY      14      2UnitUnderTestAN      10-JAN-2000 12:00
*9*1.15 81 82 83 84 85 86 87 88 89 90 91 92 93 94 95*2.24 19 20 21 22 65 66 67 6
8 69 70 71 72 73 74 75 76 77 78 79 80 104 105 106 107*3.13 8 51 52 53 54 55 56 5
7 58 59 60 63 64*4.11 35 36 37 38 39 40 41 42 43 44 45*8*4.1 81*8*3.4 77 79 104
106*4.2 80 83*8*10*11
```

5.15 SETTLED_STATE_&_PULSES file

File type name: SETTLED_STATE_&_PULSES

File name: setldpuls.tap

File number: 15

Description: This file is an incremental representation of the settled state of the circuit according to the simulator, meaning that only nodes that change their behavior from one pattern to the next are identified. It presents the node state, pulse, no pulse, and possible pulse data for each node that transitions on each pattern. It is assumed that sufficient time has been allocated to allow all of the nodes to settle out, and that their state is determined by a strobe at the end of the pattern. It is assumed that the pulse can occur anywhere within the pattern, and still be captured by the probe.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1:10 - Contains the minimum safe pulse width (I10) (note 2)

Line 3 to N: Columns 1:80 - Contains SETTLED_STATE_ONLY and pulse data (note 3)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—Minimum safe pulse width is expressed in STU as the minimum duration for which a pulse must transition to a known (Hi or Lo) state and return to be definitely detected. If a node transitions from Hi to Lo, or Lo to Hi only once, without entering the X or Z state at any time within a pattern, it is considered to be pulseless. If a node does not fit into either of these categories (i.e., transitions to X, Z, or pulses for less than the minimum time required), then it “possibly pulses.”

3—The data is identical to that in the SETTLED_STATE_ONLY file except that the pulse information is included. The op codes for this file are an extension of the SETTLED_STATE_ONLY file. They are as follows:

op code	Meaning
(State that the node settled without pulsing)	
1	X
2	Z
3	0
4	1
5	Not Used
6	Not Used
7	Not Used
8	End of pattern
9	Start burst marker
10	End burst marker
11	End of event file
* (asterisk)	The next number is an op code
. (period)	The next number is a count field, showing the number of user nodes that follow the count
(space)	The next number is a user node number
(State that the node settled <i>but</i> it <i>definitely</i> pulsed)	
12	X
13	Z
14	0
15	1
(State that the node settled <i>and</i> it <i>possibly</i> pulsed)	
16	X
17	Z
18	0
19	1

Example:

```

SETTLED_STATE_&_PULSES    15    2UnitUnderTestAO        10-JAN-2000 12:00
10
*9*3.7 8 51 52 55 56 60 64*4.15 1 2 3 7 9 10 13 14 15 42 45 46 48 49 50 98*16.10
81 82 83 84 85 86 91 92 93 94*17.15 19 20 21 22 70 71 72 73 74 75 76 77 78 79 8
0*18.2 57 63*19.11 33 34 35 36 37 38 39 40 41 43 44*8*3.9 57 63 81 82 83 84 85 8
6 95*4.13 33 34 35 36 37 38 39 40 41 43 44 47 62*15.1 3*8*4.2 3 81*8*3.4 77 79 1
04 106*4.7 78 80 82 83 84 85 107*14.1 63*15.5 1 6 7 44 62*8*3.12 9 10 11 12 13 1
4 15 16 17 18 78 107*4.4 77 79 104 106*883.2 79 106*4.2 18 81*8*3.4 18 77 81 104 *4.4
17 78 82 105*8*3.4 17 78 82 105*4.4 16 79 83 106*8*3.4 16 79 83 106*4.4 15 80 84
107*8*4.11 1 9 10 11 12 13 14 78 81 82 83*14.1 57*15.8 4 33 34 35 36 37 39 47*8*3.10 9
10 11 12 13 14 15 16 17 107*4.4 77 79 104 106*8*3.2 79 106*4.2 18 81 *8*3.4 18 77 81
104*4.4 17 78 82 105*8*3.4 17 78 82 105*4.4 16 79 83 106*8*3.4 1 6 79 83 106*4.4 15 80
84 107*8*10*11

```

5.16 NODE_SOURCE file

File type name: NODE_SOURCE

File name: nodsource.tap

File number: 16

Description: This file provides the information necessary for each user node and identifies which output on the package (or PI) drives or sources that node. This information is depicted in pairs of numbers. The first number of each pair identifies the package number and the second number of each pair is a pointer to the OUTPUT_PIN_NAMES file where the source pin name is located. To use this file to find the source of a user node, use the first number of the pair for the package number in the MAIN_MODEL file to find both the package name and the component type. The component type leads to the COMPONENT_TYPE file which will in turn lead to the OUTPUT_PIN_NAMES file to identify the appropriate pin name and the INPUT_PIN_NAMES file for the node source information.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1:10 - Number of user nodes (I10)

Line 3 to N: Columns 1:80 - Node source packets (10(I5,I3)) (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—The first integer of the packet is a main model component number, or zero. The second integer of the packet is an index to the OUTPUT_PIN_NAMES file (the value of the index is the starting position in the group of pins in the OUTPUT_PIN_NAMES file pointed to by the COMPONENT_TYPE file) OR if the first integer is zero, the second integer of the packet is a PI number or the number of a pseudo PI plus the number of PIs (if the second number of the packet is greater than the number of PIs, subtract the number of PIs to get the pseudo PI number).

Example:

NODE_SOURCE		16		2UnitUnderTestOP		10-JAN-2000		12:00											
25																			
0	1	0	2	0	3	0	4	0	5	0	6	0	7	0	8	0	9	0	10
0	0	0	0	0	0	0	0	0	0	1	1	1	2	1	3	2	1	2	2
3	1	3	2	0	15	0	17	0	18										

5.17 STEPS file

File type name: STEPS

File name: steps.tap

File number: 17

Description: This file provides information defining which patterns are useful for fault dictionary and probe based fault isolation testing of the UUT. It lists only those patterns that have useful fault information associated with them, i.e., only those patterns that detect previously undetected faults at internal package pins or POs, and those patterns that subdivide previously detected fault sets at POs. Only those patterns included here need to be looked at with a probe, since only those patterns contain information that can diagnose a fault. A step is a pattern that is necessary for diagnosing faults for which logic state information about probeable nodes should be available to the test job, specifically the probe. This file applies only to faults simulated and if the probe method is a strobe at the end of the pattern.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1:10 - Total number of steps (test patterns)(I10)

Line 3 to N: Columns 1:80 - Contains steps (8(I10)) (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—Each step entry is a 10-character integer that represents a test pattern number. Positive entries are used when a new fault is detected at a primary output. Negative entries are for use with patterns that make a fault visible for the first time on a probeable node (net).

Example:

STEPS		17	2UnitUnderTestAQ		10-JAN-2000	12:00
	7					
	1	2	5	-6	-9	11 -15

5.18 F.D._POPATS file

File type name: F.D._POPATS

File name: fdpopats.tap

File number: 18

Description: This file lists all of the PO pins on a pattern-by-pattern basis that were determined by fault simulation to be useful for fault isolation. This information is contained in pairs. The first number of the pair is the PO pin number index into the PO_NAMES file. The second number of the pair is the Pattern number (PAT), i.e., POPAT. The POPAT pairs are numbered sequentially.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1: 5 - Total number of POPATs (I5)

Line 3 to N: Columns 1:80 - POPAT packets (8(I4,I6)) (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—The first integer in the packet contains the primary output number, whereas the second integer contains the pattern number.

Example:

F.D._POPATS					18	2UnitUnderTestAR										10-JAN-2000	12:00
15																	
1	1	2	1	3	1	4	1	2	4	4	4	1	5	3	5		
3	10	2	11	4	11	4	12	3	13	2	14	1	15				

5.19 F.D._FAULT_SIGNATURES file

File type name: F.D._FAULT_SIGNATURES

File name: fdfsig.tap

File number: 19

Description: This file identifies the fault set and the corresponding POPATs that are predicted by the simulator to detect it (its fault signature). Each fault set starts on a new line.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1: 6 - Total number of fault sets (I6)
Columns 7:12 - Most number of POPATs for a fault set (I6)

Line 3 to N: Columns 1: 6 - Fault set Last Analyzed POPAT (FLAP) number (I6) (note 2)
Columns 7:12 - Total number of POPATs in the signature for this fault set (I6)
Columns 13:18 - Contains the first POPAT of the fault signature (I6) (note 3)
Columns 19:24 - Contains the second POPAT of the fault signature (I6) (note 3)
Columns 25:30 - Contains the third POPAT of the fault signature (I6) (note 3)
Columns 31:36 - Contains the fourth POPAT of the fault signature (I6) (note 3)
Columns 37:42 - Contains the fifth POPAT of the fault signature (I6) (note 3)
Columns 43:48 - Contains the sixth POPAT of the fault signature (I6) (note 3)
Columns 49:54 - Contains the seventh POPAT of the fault signature (I6) (note 3)
Columns 55:60 - Contains the eighth POPAT of the fault signature (I6) (note 3)
Columns 61:66 - Contains the ninth POPAT of the fault signature (I6) (note 3)
Columns 67:72 - Contains the tenth POPAT of the fault signature (I6) (note 3)
Columns 73:78 - Contains the eleventh POPAT of the fault signature (I6) (notes 3/4)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—The FLAP number identifies to the user whether or not to use all POPATs for analysis. A positive FLAP number of +N indicates that the first *N* POPATs were useful in fault simulation and that only these *N* POPATs should be used on the tester for fault signature analysis for this fault set (all faults in this fault set were dropped from the simulation process after POPAT *N*). Therefore, no POPATs after *N* should be used in signature analysis for this particular fault set. Signature analysis is the comparison of on-tester error pattern test results to fault simulation results predicted for each fault set. A “–1” indicates that all patterns were used in fault simulation of each fault.

3—A minus “–” sign preceding the POPAT signifies that the POPAT is a possible detect.

4—If more than eleven POPATs are contained in the fault set, they will be continued on the next new line.

Example:

F.D.	FAULT	SIGNATURES	19	2	UnitUnderTestAS	10-JAN-2000 12:00
10	6					
-1	2	1	15			
-1	3	3	9	13		
-1	1	8				
-1	1	10				
-1	2	10	11			
-1	1	11				
-1	5	10	11	12	13	14
-1	2	11	12			
-1	1	15				
-1	6	9	10	11	12	13 14

5.20 F.D._PRINT_STRINGS file

File type name: F.D._PRINT_STRINGS

File name: fdprint.tap

File number: 20

Description: This file sequentially lists each fault set in terms of faulty component information identified by the fault simulation process. The contained information is used on the tester, after fault signature analysis, to identify the faulty components that should be removed and repaired on the UUT to correct the cause of failure.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1: 6 - Total number of fault sets (I6)
Columns 7:10 - Most number of characters in a fault title (I4)
Columns 11:15 - Most number of faults in a fault set (I5)

Line 3: Columns 1: 6 - Number of lines in this fault set (I6)
Columns 7:12 - Number of fault titles (fault names) in this fault set (I6)

Line 4: Columns 1: 6 - Number of characters in the fault title (I6)
Columns 7:80 - The fault title (note 2)

Repeat line 4 until end of fault set. Line 3 and Line 4 loop repeated for all fault sets. Each fault set can be of any length, occupying one or more lines in the file.

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—A fault title is specified as an individual fault using point_name and fault state, where point_name is:

- package name and pin of a component.
- a package name followed by a signal name (signifying an input or an output of the package).
- <package.internal>pin name (signifying internal to the package).
- <^>primary I/O name (signifying primary I/O pin).
- signal name at main model level.

Fault state is represented by one of the following:

- Stuck at faults are represented by <point_name>@state, where state is 0, 1, Z.
- Open faults are represented by <point_name>/state, where state is 0, 1, Z. If state is unspecified, it is selected accordingly to the family characteristics of the device.
- Short faults are represented by <point_name>@<point_name>... All point names in the string are shorted together.

Example:

```
F.D._PRINT_STRINGS      20    3UnitUnderTestAT      10-JAN-2000 12:00
    3 12      4
    3      3      !Fault Set 1
    7<U8>4@0
10<^>DATA4@0
    7DBUS4@0
    4      4      !Fault Set 2
    7<U8>7@0
10<^>DATA3@0
10<^>DATA2@0
    7DBUS3@0
    3      3      !Fault Set 3
    7<U8>9@0
12<^>AD_LOAD/1
12<^>AD_LOAD@1
```


5.21 TRISTATE_FROMS_POINTERS file

File type name: TRISTATE_FROMS_POINTERS

File name: zfromptrs.tap

File number: 21

Description: TRISTATE_FROMS are inputs of a device that are associated with an output of that device, which are tristate enables for that output. This file is parallel to the OUTPUT_PIN_NAMES file so that each output pin on each component type has an associated TRISTATE_FROMS packet.

The data in the TRISTATE_FROMS_POINTERS file defines a TRISTATE_FROMS packet and is structured as a group of two integers. The first integer indicates the number of TRISTATE_FROMS in the packet associated with the device's output pin, and the second integer is the index into the TRISTATE_FROMS file pointing to the first TRISTATE_FROMS in the packet.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2 to N: Columns 1:80 - Eight tristate froms pointers (8(I4,I6)) (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—Each pointer consists of two integers. The first integer (4 columns) is the number of tristate froms associated with this pointer. The second integer (6 columns) is the index into the TRISTATE_FROMS file for this pointer.

Example:

TRISTATE_FROMS_POINTERS					21	2UnitUnderTestAU					10-JAN-2000 12:00				
0	1	0	1	0	1	0	1	0	1	0	1	0	1	0	1
0	1	0	1	0	1	0	1	0	1	0	1	0	1	0	1
0	1	0	1	0	1	0	1	0	1	0	1	0	1	0	1
0	1	0	1	0	1	0	1	0	1	2	3	2	5	2	7
2	9	2	11	2	13	2	15	2	17	2	19	2	21	2	23
0	25	0	25	0	25	0	25	0	25	0	25	0	25		

5.22 TRISTATE_FROMS file

File type name: TRISTATE_FROMS

File name: zfroms.tap

File number: 22

Description: TRISTATE_FROMS are inputs of a device that are associated with an output of that device, which are tristate enables for that output.

The integers in this file are organized in packets, the size of which is defined by the TRISTATE_FROMS_POINTERS file. For each packet, the TRISTATE_FROMS_POINTERS integers in each packet are an index into the INPUT_PIN_NAMES (for positive integers) and OUTPUT_PIN_NAMES (for negative integers) files. Since every TRISTATE_FROMS packet is associated with a specific device output, the TRISTATE_FROMS for the output specify the device inputs that would be probed to determine the location of the failure.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error
 in file generation (A5)

Line 2 to N: Columns 1:80 - Twenty tristate froms. (20(I4)) (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—The TRISTATE_FROMS codes are as follows:

+N → N is a pointer into the INPUT_PIN_NAMES file. This pointer assumes that the starting position is the pointer from the COMPONENT_TYPE file minus 1.

–N → N is a pointer into the OUTPUT_PIN_NAMES file. This pointer assumes that the starting position is the pointer from the COMPONENT_TYPE file minus 1.

Example:

```
TRISTATE_FROMS                   22   2UnitUnderTestAV                   10-JAN-2000 12:00
      6   5   6   5   6   5   6   5   5   6   5   6   5   6   5   6   11   12   11   12
12   11   1
```

5.23 PSEUDOPI_NAMES file

File type name: PSEUDOPI_NAMES

File name: psupinams.tap

File number: 23

Description: This file contains all of the pseudo PI pin names used in assigning a modeling logic state to package pins that are not connected to other packages. Pseudo PIs are used as sources for fixed logic states. They may be assigned to Vcc, ground, Z, X, floating, or power on reset pulse. Commonly used pseudo PI states are as follows:

\$L1	Logic 1
\$L1B	Alternate Logic 1
\$L0	Logic 0
\$L0B	Alternate Logic 0
\$LX	Unknown
\$LZ	Tristate
\$FL1	Floating high
\$FL0	Floating low
\$FLX	Floating unknown
\$PWRON	Power on LO/HI transition

Format:

Line 1:	Columns 1:24 - DTIF file type name (A24)
	Columns 25:27 - DTIF file number (I3)
	Columns 28:31 - File version number (optional value)(I4)
	Columns 32:55 - UUT name (A24)
	Columns 56:72 - File creation date and time (A17) (note 1)
	Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)
Line 2:	Columns 1:10 - Total number of pseudo PI pins (I10)
Lines 3 TO N:	Columns 1:24 - Pseudo PI name (A24) (note 2)
	Columns 25:29 - User node number connected to the specified pseudo PI (I5)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—Each line has only one pseudo PI name. A new line is started for each new pseudo PI.

Example:

PSEUDOPI_NAMES	23	2UnitUnderTestAW	10-JAN-2000 12:00
3			
\$L1	111		
\$LX	107		
\$PWRON	112		

5.24 TIMING_SETS file

File type name: TIMING_SETS

File name: timesets.tap

File number: 24

Description: The TIMING_SETS file data is based on the presumption that a timing generator exists in the tester digital hardware that will accept and store data for an optionally defined maximum number of timing sets (TSETs). Only one of these TSETs may be in effect on any given pattern. It, and only it, is the timing source for all of the I/O pins on the tester for that pattern. TSETs allow the user to specify, for each I/O pin, when to start and when to stop applying stimulus or measuring the output response available at that I/O pin. The time period for application of stimulus is called a PHASE and the time period allocated to the observation of a response is called a WINDOW. The PHASE defines the assert and return times. The assert time defines when a logic state will be applied to an input pin and the return time defines when a logic state will be removed from the output pin. After the return time, the input pin will remain in a state defined by the PI_FORMATS and FORMAT_ATTRIBUTES files until the next assert time. Each WINDOW has an open and close time defined for it. A UUT signal must be present from open to close time to be considered a valid state detection. TSETs cannot be changed during a pattern. The timing generator is driven by a clock that has a user defined resolution of typically 1 STU. Each TSET will also have its own clock period based on some multiple of the defined STU.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1: 5 - Highest TSET number defined (I5)
Columns 6:10 - Total number of TSETS (I5)
Columns 11:15 - Maximum number of PHASEs per TSET (I5)
Columns 16:20 - Maximum number of WINDOWS per TSET (I5)
Columns 21:30 - Number of simulation time units (STU) (I10)
Columns 31:33 - Timing units (units must match the value in the EVENTS file) (I3)

Line 3 to N: Columns 1: 5 - Line type (1,2,3, or 4) (note 2)

Line Type 1 (TSET header):

Columns 6:13 - TSET number (I8)
Columns 14:28 - TSET clock period in STU (I15)
Columns 29:32 - Number of PHASEs (I4)
Columns 33:36 - Number of WINDOWS (I4)

Line Type 2 (PHASE line):

Columns 6:13 - Phase number (I8)
Columns 14:21 - TSET number (I8)
Columns 22:36 - Assert time in STU (I15)
Columns 37:51 - Return time in STU (I15)

Line Type 3 (WINDOW line):

Columns 6:13 - Window number (I8)
Columns 14:21 - TSET number (I8)
Columns 22:36 - Open time in STU (I15)
Columns 37:51 - Close time in STU (I15)

Line Type 4 (trigger line): (note 3)
 Columns 6:13 - Phase number (I8)
 Columns 14:18 - Trigger type (1: PHASE triggers off the
 beginning of the pattern, 2:PHASE triggers off the
 clock pulse)(I5)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—No PHASE or WINDOW line will occur before the corresponding TSET HEADER line for that TSET.

3—All timing specifications are integer only. All trigger lines occur at the end of the file.

Example:

TIMING_SETS				24	2UnitUnderTestAX	10-JAN-2000 12:00
32	1	16	16	1-12		
1		1		1000000	2 1	
2		1			11000	950000
2		2			40000	950000
3		1			70000	750000
4		1				
4		2				

5.25 TIMING_PER_PATTERN file

File type name: TIMING_PER_PATTERN

File name: timperpat.tap

File number: 25

Description: This file is used to control the selection of one, and only one, TSET at a time for simulation or on-station testing of the UUT.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error
 in file generation (A5)

Line 2: Unused

Line 3 to N: Columns 1:10 - Pattern number (I10) (note 2)
 Columns 11:18 - TSET number (I8)
 Columns 19:26 - Clocks per pattern (I8)
 Columns 27:36 - Pattern number (I10)
 Columns 37:44 - TSET number (I8)
 Columns 45:52 - Clocks per pattern (I8)
 Columns 53:62 - Pattern number (I10)
 Columns 63:70 - TSET number (I8)
 Columns 71:78 - Clocks per pattern (I8)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—There are three entries per line with the last two character positions on the line unused.

Example:

```
TIMING_PER_PATTERN      25      1UnitUnderTestAY      10-JAN-2000 12:00
      1      1      1      16      1      1
```

5.26 PHASE_CONNECTIONS file

File type name: PHASE_CONNECTIONS

File name: phaseconn.tap

File number: 26

Description: This file provides the assignment of primary input and output pins to PHASEs and WINDOWs produced by the TIMING_SETS file.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1: 5 - Number of lines in the file giving PI PHASE assignments (I5) (note 2)
Columns 6:10 - Number of lines in the file giving PO WINDOW assignments (I5) (note 2)
Columns 11:15 - Number of PIs that have assigned PHASEs (I5)
Columns 16:20 - Number of POs that have assigned WINDOWs (I5) (note 3)

Line 3 to (3+M): Columns 1: 5 - PI number (I5) (note 4)
Columns 6:13 - Phase number (I8)

Line (4+M) to N: Columns 1: 5 - PO number (I5)
Columns 6:13 - Window number (I8)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—The number of PI lines will be the number of PIs. The number of PO lines will be the number of POs.

3—Under certain conditions, not all POs will be assigned WINDOWs. In these situations, POs without assigned WINDOWs will have zero (0) as their WINDOW number.

4—M is equal to the number of PIs that have assigned PHASEs (line 2, columns 11:15).

Example:

```

PHASE_CONNECTIONS      26    2UnitUnderTestAZ      10-JAN-2000 12:00
  9      6      9      4
  1      5
  2      1
  3      3
  4      5
  5      2
  6      1
  7      1
  8      4
  9      1
 10      1
 11      1
 12      1
 13      1
 14      1
 15      0
 16      0

```

5.27 AUXILIARY_PIN_NAMES file

File type name: AUXILIARY_PIN_NAMES

File name: auxpins.tap

File number: 27

Description: This file provides an alternate selection of ground and power pins on the tester at the component level. Entries in this file are pointed to by the COMPONENT_TYPE file entries.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error
 in file generation (A5)

Line 2: Columns 1:10 - Number of component Types (I10)

Line 3 to N: Columns 1: 8 - Component type number (I8)
 Columns 9:24 - Ground pin name (A16)
 Columns 25:40 - Power pin name (A16)
 Columns 41:56 - Alternate ground pin name (A16)
 Columns 57:72 - Alternate power pin name (A16)

NOTE

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

Example:

AUXILIARY_PIN_NAMES	27	2UnitUnderTestBA	10-JAN-2000 12:00
2			
1GND_PIN	PWR_PIN	ALT_GND	ALT_PWR
2			

[illegible]

5.29 FORMAT_ATTRIBUTES file

File type name: FORMAT_ATTRIBUTES

File name: formattrs.tap

File number: 29

Description: This file defines the relationship between the stimulus PI pin format identifiers and their associated name.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1: 4 - Number of format data lines (I4)

Line 3 to N: Columns 1: 4 - PI pin format number (I4) (note 2)
Columns 5:19 - PI pin format name (A15)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—The following are five possible formats:

- \$NRET - Non-return (retains the same level as the last stimulus state specified)
- \$RZERO - Return to zero
- \$RONE - Return to one
- \$RCOMP - Return to complement
- \$ROFF - Return to 'off' - stimulus driving HIZ

Example:

```
FORMAT_ATTRIBUTES      29      2UnitUnderTestBC      10-JAN-2000 12:00
5
0$NRET
1$RZERO
2$RONE
3$RCOMP
4$ROFF
```

5.30 F.D. _CROSS_REFERENCE file

File type name: F.D. _CROSS_REFERENCE

File name: fdxref.tap

File number: 30

Description: This file provides a table for cross-referencing each POPAT with the fault sets it is capable of detecting. Each list of fault sets here implicitly applies to the corresponding entry in the F.D._POPATS file.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1: 5 - Number of POPATs (I5)
Columns 6:10 - Greatest number of fault sets in POPAT list (I5)
Columns 11:12 - Unused (I2)
Columns 13:14 - Unused (I2)

Line 3 to N: Columns 1:80 - POPAT isolation (cross-reference) data (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—POPAT isolation data contains a list of fault sets for each POPAT. Each line is organized as lists of fault set numbers, with each list preceded by the size of the list (i.e., the number of list elements). Each list begins on a new line, with the list size starting in column 1; the list of elements uses as many lines as necessary. A fault set number is not broken over two lines. If the current line does not have room for the six-character fault set value, then the value starts in column 1 of the next line. A negative value for the fault set number indicates that the corresponding POPAT possibly detects the fault set.

Example:

F.D.	CROSS_REFERENCE	30	2UnitUnderTestBD	10-JAN-2000 12:00
7	6			
1	1			
1	2			
1	3			
4	17	3	14	-18
6	10	9	17	2
4	17	2	15	12
2	1	16		

5.31 PROBETAG_ DEFINITIONS file

File type name: PROBETAG_ DEFINITIONS

File name: probetag.tap

File number: 31

Description: This file describes the operating parameters for a diagnostic probe, when used. Parameters specified include: timing resolution, delays, voltage threshold, and skew limits.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1: 8 - Timing resolution value (I8)
Columns 9:16 - Units of time (I8)
Columns 17:24 - The minimum detectable pulse width for use with a probe in STU (I8)
Columns 25:32 - The minimum probe delay in STU (I8)
Columns 33:40 - The maximum probe delay in STU (I8)
Columns 41:48 - The minimum probe skew in STU (I8)
Columns 49:56 - The maximum probe skew in STU (I8)
Columns 57:65 - The probetags in this file (I9)
Columns 66:67 - The number of lines per probetag (I2)
Columns 68:71 - Maximum number of PSETs per probetag (I4)

Line 3: Columns 1:20 - Probetag names in character strings (A20) (note 2)
Columns 21:28 - Logic low voltage in millivolts (I8)
Columns 29:36 - Logic high in millivolts (I8)
Columns 37:40 - Probetag mapping class (I4) (note 3)
Columns 41:48 - Timing data for WINDOW open in STU for PSET1 (I8)
Columns 49:56 - Timing data for WINDOW close in STU for PSET1 (I8)

Line 4 to 6: Columns 1:80 - 5-paired WINDOW open and close times in STU for PSETs 2 through 16 (5*(I8,I8)) (note 4)

Line 7 to (4*N): Columns 1:80 - PROBETAG_ DEFINITIONS data (note 5)

NOTES

- 1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].
- 2—Actual probetag data begins with line 3. Each probetag data set requires a total of four lines.
- 3—This field contains one of the following values: –1, 0, 1, 2, 3, 4. These values are defined as follows:
 - 1 Unspecified
 - 0 Settled
 - 1 Settled to X
 - 2 Pulse
 - 3 Highlow
 - 4 Highlow–X
- 4—There is a maximum of 16 possible PSETs. The first pair of numbers appearing in line 4 for a set apply to PSET 2, since the open and close times for PSET 1 appear in line 3 after the mapping class. The first number in the pair is the WINDOW open time and the second number is the WINDOW close time.
- 5—Additional four-line sets repeat the format of lines 3–6, one set per probetag in a set.

Example:

```

PROBETAG_DEFINITIONS      31      2UnitUnderTestBE      10-JAN-2000 12:00
1      -12      10000      0      0      -5000      5000      3 4 16
SDF_P      1000      2000      2      0      970000
0 970000      0 970000      0 970000      0 970000      0 970000
0 970000      0 970000      0 970000      0 970000      0 970000
0 970000      0 970000      0 970000      0 970000      0 970000
SDF_S      1000      2000      4 972000 995000
972000 995000 972000 995000 972000 995000 972000 995000 972000 995000
972000 995000 972000 995000 972000 995000 972000 995000 972000 995000
972000 995000 972000 995000 972000 995000 972000 995000 972000 995000
DEFAULT
972000 995000 972000 995000 972000 995000 972000 995000 972000 995000
972000 995000 972000 995000 972000 995000 972000 995000 972000 995000
972000 995000 972000 995000 972000 995000 972000 995000 972000 995000

```

5.32 PROBETAG_ASSIGNMENTS file

File type name: PROBETAG_ASSIGNMENTS

File name: probeasgn.tap

File number: 32

Description: This file assigns a probe, defined in PROBETAG_DEFINITIONS, to each probeable node in the circuit.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Not used

Line 3 to N: Columns 1:80 - Index into the PROBETAG_DEFINITIONS (20*(I4)) (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—This field provides a probe assignment for each user node using user node order. Each assignment has four characters that specify an index into the PROBETAG_DEFINITIONS file. If the index is zero, no probetag is assigned to the node (net).

Example:

PROBETAG_ASSIGNMENTS	32	2UnitUnderTestBF	10-JAN-2000	12:00															
1	2	1	1	2	1	1	3	2	2	2	2	2	2	2	2	2	2	2	2
2	2	0	0	0	0	0	0	0	0	0	1	1	1						

5.33 BURSTS file

File type name: BURSTS

File name: bursts.tap

File number: 33

Description: This file defines the burst register storage depth requirements behind each I/O pin, and the starting pattern number for each successive burst.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1: 5 - Number of bursts (I5)
 Columns 6:15 - Number of patterns in the simulation (I10)
 Columns 16:20 - Number of first burst (usually '1') (I5)

Line 3 to N: Columns 1:10 - Pattern number of each new burst (I10) (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—An extra burst entry signifies the end-of-file. The entry is (number of patterns + 1). This is not included in Line 2/ Columns 1:5, the number of bursts entry.

Example:

```
BURSTS      33      2UnitUnderTestBG      10-JAN-2000 12:00
  1          15      1
    1
   16
```

5.34 STIMULUS_TEXT file

File type name: STIMULUS_TEXT

File name: stimtext.tap

File number: 34

Description: This file provides a way for the simulation developer to include messages from the stimulus set into the TPS file.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1:10 - Number of patterns in simulation (I10)

Line 3 to N: Column 1 - Op code of stimulus text information (note 2)
 Columns 2:80 - Stimulus text information (note 3)

'P' op code Columns 2:11 - Pattern number of new pattern (note 4)

'M' op code Columns 2: 5 - Length of message text
 Columns 6: n - Message text, using as many successive lines as necessary

'L' op code Columns 2: 5 - Length of label name
 Columns 6: n - Label name, using as many successive lines as necessary

'T' op code Columns 2: 5 - Length of test text
 Columns 6: n - Test text, using as many successive lines as necessary

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—The stimulus text information is one of three types: MESSAGE, LABEL, or TEST TEXT. MESSAGE refers to documentation, specifically comments in the stimulus. LABEL simply means that the stimulus was assigned a label at this point. TEST TEXT means that there is some text that should be inserted directly, unedited, into the tester job plan. The file is a series of op codes with accompanying information. Each op code starts on a new line, regardless of where the previous op code information leaves off on the previous line. There are four possible codes:

op code	Meaning
P	Start of Pattern (note 4)
M	Message Text
L	Label Name
T	Test Text

3—The format for the stimulus text information is different for each op code.

4—There will not be a 'P' op code for every pattern, but only for those patterns that contain at least one line of text.

Example:

```
STIMULUS_TEXT      34    2UnitUnderTestBH      10-JAN-2000 12:00
      15
P          4
M  20Writing data to rams
P          10
M  22Reading data from rams
```


5.35 NODE_NAMES file

File type name: NODE_NAMES

File name: nodenames.tap

File number: 35

Description: This file identifies all of the user defined node names, other than PI_NAMES and PO_NAMES.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error in
 file generation (A5)

Line 2: Columns 1:10 - Highest user node number (I10) (note 2)
 Columns 11:20 - Number of user nodes with user-given node names
 (I10)

Line 3 to N: Columns 1:10 - User node number (I10) (note 3)
 Column 11 - Unused
 Columns 12:43 - Node name character string (A32)

NOTES

- 1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].
- 2—This file will only contain the node names that were explicitly assigned by the user.
- 3—This information will be in ascending order of user node number.

Example:

```
NODE_NAMES          35    2UnitUnderTestBI      10-JAN-2000 12:00
  117                10
  100 DBUS4
  101 DBUS3
  102 DBUS2
  103 DBUS1
  104 IDBUS1
  105 IDBUS2
  106 IDBUS3
  107 IDBUS4
  108 $L1B
  109 $L0B
```

5.36 EVENTS_INIT file

File type name: EVENTS_INIT

File name: eventsinit.tap

File number: 36

Description: This file contains circuit initialization information using the same format as the EVENT file. The circuit initialization event is produced by simulating a pattern that sets all the primary inputs to an unknown state, and sets all pseudo PI nodes to their respective value. This file also includes the states for nodes that are determined at power-up time.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1:10 - Timing resolution value (I10) (note 2)
Columns 11:14 - Unit of time (I4)

Line 3 to N: Columns 1:80 - Contiguous stream of events data (note 3)

NOTES

- 1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].
- 2—The timing resolution value is a positive integer that, in conjunction with the units of time, represents the STU. If the resolution is 5 and the units of time is –9, the STU is 5 nanoseconds.
- 3—An event is composed of a two-part data grouping consisting of an integer followed by an alphanumeric op code, which determines the meaning of the integer value. The integer value represents either time in STU, node number, or a pattern number depending on the op code it precedes. Time values are interpreted as either delta time from the last event or absolute time from the beginning of the pattern depending upon the op code. If the integer value is missing, event time is assumed to be the same as the most recent time value within the pattern. The single-character op codes are as follows:

<u>op code</u>	<u>Meaning</u>
@	Absolute time relative to start of a pattern
A	A relative (delta) time field; specifying the minimum time at which the nodal event might occur. The specified nodes are in a stable state prior to this point in time.
B	A relative (delta) time field; specifying the minimum time at which the nodal event might occur. All of the specified nodes are in an unstable state prior to this point in time.
C	A relative (delta) time field; specifying the maximum time at which the nodal event might occur. These specified nodes are in a stable state after this point in time.
D	A relative (delta) time field; specifying the maximum time at which the nodal event might occur. All of these specified nodes are in an unstable state after this point in time.
E	User node number that just went 'low' or '0'
F	Unused
G	Unused
H	User node number that just went 'high' or '1'
I	Unused
J	Unused
K	User node number that just went to 'Z' or high impedance
L	Unused
M	Unused
N	User node number that just went to 'X' or unknown
O	Unused
P	End of pattern
Q	End of Burst
R	End-of-file (This should never be preceded by an integer.)

Example:

```
EVENTS_INIT          36    2UnitUnderTestBJ      10-JAN-2000 12:00
                      1 -12
0A1K2K3K4K5K6K7K8K9K10K11K12K13K14K15K16K17K18K19K20K21K22K117H108H116E109E111K1
12H113E115EC1K2K3K4K5K6K7K8K9K10K11K12K13K14K15K16K17K18K19K20K21K22K117H108H116
E109E111K112H113E115E1A96H97H98H99HC96H97H98H99H4266A45H26H2400A52E53E54E55E56E5
8E59E60E2242A49H50H6091C45H46H52E53E54E55E56E58E59E60E7000C49H50H978000A115HC115
H1000001@0P
```

5.37 EQUIV_FAULTS file

File type name: EQUIV_FAULTS

File name: equivflts.tap

File number: 37

Description: This file contains the fault titles organized in groups of equivalent faults with each group assigned a unique number. Equivalent faults are faults that will produce identical responses that are indistinguishable at the primary output, regardless of the stimulus.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1: 4 - Number 'M' of fault title types (I4)
Columns 5:12 - Number of equivalent fault groups (I8)
Columns 13:20 - Total number of faults in the file (I8)
Columns 21:24 - Length for largest fault title type (I4)

Line 3 to (M+2): Columns 1: 4 - Fault title type (one type per line) (I4)
Columns 5:80 - Fault title type description (A76)

Line (M+3) to N: Columns 1: 8 - Equivalent fault group number (I8)
Columns 9:16 - Number of faults in equivalent fault group (I4)
Columns 17:20 - Fault title type (I4)
Columns 21:24 - Length of the following fault title (I4)
Columns 25-80 - Fault title (A56) (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—If the length of the fault title exceeds 56 characters, a new record will be generated, up to 80 characters.

Example:

```
EQUIV_FAULTS          37    2UnitUnderTestBK          10-JAN-2000 12:00
  9      12      32  12
1Stuck-at-0
2Stuck-at-1
3Stuck-at-Z
4Stuck-at-X
5Open-to-0
6Open-to-1
7Open-to-Z
8Open-to-X
9Shorted nodes
  1      1      7      8<U8>10/Z
  2      1      2      7<U8>5@1
  3      1      1      8<U7>16@0
  4      2      5      7<U3>4/0
  5      5      2      12<^>AD_LOAD@1
  6      1      6      12<^>AD_LOAD/1
  7      3      5      7<U1>3/0
  8      3      7      7<U2>5/Z
  9      2      5      7<U9>9/0
10      7      2      8<U9>11@1
11      4      1      11<^>DATA3.@0
12      2      5      11<^>DATA3./0
```

5.38 PROBE_DETECTION file

File type name: PROBE_DETECTION

File name: probedet.tap

File number: 38

Description: This file contains a list of equivalent fault groups that will be detected by a probe placed on the indicated user node at the end of the indicated pattern.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
Columns 25:27 - DTIF file number (I3)
Columns 28:31 - File version number (optional value)(I4)
Columns 32:55 - UUT name (A24)
Columns 56:72 - File creation date and time (A17) (note 1)
Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1: 8 - Number of lists of equivalent fault group numbers (I8) (note 2)
Columns 9:16 - Size of the longest list (I8)
Columns 17:24 - Highest equivalent fault group number in any list (I8)

Line 3 to N: Columns 1: 8 - Pattern number for this probe measurement (I8)
Columns 9:16 - User node number on which the probe would be placed (I8) (note 3)
Columns 17:24 - Number of equivalent fault groups (I8)
Columns 25:80 - Each equivalent fault group (I8) (note 4)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—The actual fault titles may be determined by using the EQUIV_FAULTS file.

3—A positive number indicates that the expected fault-free state of the node is high. A negative number indicates that the expected fault-free state of the node is low.

4—Additional records are utilized when needed. The equivalent fault group numbers listed are those that are being detected now that have not been detected at this user node on an earlier pattern. Further, if the faults of an equivalent fault group are ‘possibly’ detected, the set number is negative in the list.

Example:

PROBE_DETECTION		38	2UnitUnderTestBL	10-JAN-2000 12:00
14	9	191		
1	1	1	65	
1	-2	1	67	
1	3	2	71	109
1	4	3	71	109 111
1	5	4	71	109 111 113
1	6	5	71	109 111 113 115
1	7	6	71	109 111 113 115 117
1	9	7	71	109 111 113 115 117 119
1	12	8	71	109 111 113 115 117 119
121				
1	13	9	71	109 111 113 115 117 119
121	123			
2	-25	3	-70	-186 189
2	-21	3	-70	-186 191
3	-30	1	77	
3	-26	3	77	-186 18

5.39 F.D._EQUIV_SETS file

File type name: F.D._EQUIV_SETS

File name: fdeqvs.tap

File number: 39

Description: This file uses the equivalent fault groups from EQUIV_FAULTS to define the faults contained in each fault set.

Format:

Line 1: Columns 1:24 - DTIF file type name (A24)
 Columns 25:27 - DTIF file number (I3)
 Columns 28:31 - File version number (optional value)(I4)
 Columns 32:55 - UUT name (A24)
 Columns 56:72 - File creation date and time (A17) (note 1)
 Columns 73:77 - Either spaces or "ERROR" to indicate an error in file generation (A5)

Line 2: Columns 1: 8 - The number of fault sets (I8)
 Columns 9:16 - Total number of equivalence fault group numbers (I8)
 Columns 17:24 - Highest equivalence fault group number (I8)
 Columns 25:32 - Largest number of equivalence fault groups in any fault set (I8)

Line 3 to N: Columns 1: 8 - Fault set number (I8)
 Columns 9:16 - Size of the list (I8)
 Columns 17:80 - List of equivalence fault group numbers (I8) (note 2)

NOTES

1—Date and Time are represented as: dd-mmm-yyyy hh:mm [dd – day, mmm – month, yyyy – year, hh – hour (24 hour clock), mm – minutes].

2—The information for each fault set begins with a new line and uses as many lines as required.

Example:

F.D._EQUIV_SETS	39	2UnitUnderTestBM	10-JAN-2000	12:00
11 40	227	12		
1 2	101	220		
2 2	103	222		
3 2	105	224		
4 2	107	226		
5 2	104	223		
6 2	108	227		
7 2	102	221		
8 2	106	225		
9 6	45	50	99	100
10 12	38	46	48	49
192 193	196	197	190	191
11 6	40	47	93	94
			97	98
			194	195

6. Conformance

This clause describes the capabilities required for implementing the standard. Conformance to the standard is divided into three areas that are mutually independent. An application shall satisfy the required functions in the following areas, as applicable, in order to comply with this standard:

- a) End-to-end test;
- b) Diagnostics using Fault Dictionary;
- c) Diagnostics using Probe.

The required set of files listed for each area are indicated by file type name in uppercase letters, and shall use the file name in parenthesis.

6.1 End-to-end test

The intent of an end-to-end test of a UUT is to verify the overall functionality of the item, and to indicate a failure if one exists and can be detected by the test pattern set developed for it. There is no explicit attempt to diagnose the cause of the failure.

The required set of DTIF files that would enable the generation of an end-to-end test of a digital UUT using static patterns are

HEADER (header.tap)
STIMULUS (stimulus.tap)
PO_RESPONSE (response.tap)
PI_NAMES (pinames.tap)
PO_NAMES (ponames.tap)
TIMING_PER_PATTERN (timperpat.tap)
BURSTS (bursts.tap)
STIMULUS_TEXT (stimtext.tap)

The required set of DTIF files that would enable the generation of an end-to-end test of a digital UUT using dynamic patterns are

HEADER (header.tap)
STIMULUS (stimulus.tap)
PO_RESPONSE (response.tap)
PI_NAMES (pinames.tap)
PO_NAMES (ponames.tap)
TIMING_SETS (timesets.tap)
TIMING_PER_PATTERN (timperpat.tap)
PHASE_CONNECTIONS (phaseconn.tap)
PI_FORMATS (piformats.tap)
FORMAT_ATTRIBUTES (formattr.tap)
BURSTS (bursts.tap)
STIMULUS_TEXT (stimtext.tap)

6.2 Diagnostic test using fault dictionary

Fault isolation by fault dictionary is a diagnostic test technique that does not require physical probing of a circuit. Data generated by a fault simulator is analyzed and generally arranged into matrices that match fault

indications with a characteristic failing response at the primary output pins of the UUT. Actual failing responses are captured on the ATE and compared to the fault dictionary matrix for fault isolation.

The required set of DTIF files that would enable the generation of fault dictionary diagnostics for a UUT using static patterns are

HEADER (header.tap)
STIMULUS (stimulus.tap)
PO_RESPONSE (response.tap)
PI_NAMES (pinames.tap)
PO_NAMES (ponames.tap)
MAIN_MODEL (mainmodel.tap)
COMPONENT_TYPE (types.tap)
USER_NODE (usernodes.tap)
INPUT_PIN_NAMES (inputpins.tap)
OUTPUT_PIN_NAMES (outputpin.tap)
F.D._POPATS (fdpopats.tap)
F.D._FAULT_SIGNATURES (fdfltsig.tap)
F.D._PRINT_STRINGS (fdprint.tap)
PSEUDOPI_NAMES (psupinams.tap)
TIMING_PER_PATTERN (timperpat.tap)
AUXILIARY_PIN_NAMES (auxpins.tap)
F.D._CROSS_REFERENCE (fdxref.tap)
BURSTS (bursts.tap)
STIMULUS_TEXT (stimtext.tap)
NODE_NAMES (nodenames.tap)
EQUIV_FAULTS (equivflts.tap)
F.D._EQUIV_SETS (fdeqvs.tap)

The required set of DTIF files that would enable the generation of fault dictionary diagnostics for a UUT using dynamic patterns are

HEADER (header.tap)
STIMULUS (stimulus.tap)
PO_RESPONSE (response.tap)
PI_NAMES (pinames.tap)
PO_NAMES (ponames.tap)
MAIN_MODEL (mainmodel.tap)
COMPONENT_TYPE (types.tap)
USER_NODE (usernodes.tap)
INPUT_PIN_NAMES (inputpins.tap)
OUTPUT_PIN_NAMES (outputpin.tap)
F.D._POPATS (fdpopats.tap)
F.D._FAULT_SIGNATURES (fdfltsig.tap)
F.D._PRINT_STRINGS (fdprint.tap)
PSEUDOPI_NAMES (psupinams.tap)
TIMING_SETS (timesets.tap)
TIMING_PER_PATTERN (timperpat.tap)
PHASE_CONNECTIONS (phaseconn.tap)
AUXILIARY_PIN_NAMES (auxpins.tap)
PI_FORMATS (piformats.tap)
FORMAT_ATTRIBUTES (formattrts.tap)
F.D._CROSS_REFERENCE (fdxref.tap)
BURSTS (bursts.tap)

STIMULUS_TEXT (stimtext.tap)
NODE_NAMES (nodenames.tap)
EQUIV_FAULTS (equivflts.tap)
F.D._EQUIV_SETS (fdeqvs.tap)

6.3 Diagnostic test using probe

Isolating faults using a probe is a diagnostic test technique that utilizes a probe connected to the ATE to aid in isolating failures on the UUT. The information required to generate a probe diagnostic test includes a detailed description of the circuit that would help direct the test operator where to probe, and data to determine whether or not a response monitored by the probe matched the good circuit response.

The required set of DTIF files that would enable the generation of probe diagnostics for a digital UUT using static patterns are

HEADER (header.tap)
STIMULUS (stimulus.tap)
PO_RESPONSE (response.tap)
PI_NAMES (pinames.tap)
PO_NAMES (ponames.tap)
MAIN_MODEL (mainmodel.tap)
COMPONENT_TYPE (types.tap)
USER_NODE (usernodes.tap)
INPUT_PIN_NAMES (inputpins.tap)
OUTPUT_PIN_NAMES (outputpin.tap)
NEAR_FROMS_POINTERS (nerfrmprtr.tap)
NEAR_FROMS (nearfroms.tap)
EVENT (events.tap)
SETTLED_STATE_ONLY (setldonly.tap)
NODE_SOURCE (nodsource.tap)
STEPS (steps.tap)
TRISTATE_FROMS_POINTERS (zfromptrs.tap)
TRISTATE_FROMS (zfroms.tap)
PSEUDOPI_NAMES (psupinams.tap)
TIMING_PER_PATTERN (timperpat.tap)
AUXILIARY_PIN_NAMES (auxpins.tap)
PROBETAG_DEFINITIONS (probetag.tap)
PROBETAG_ASSIGNMENTS (probeasgn.tap)
BURSTS (bursts.tap)
STIMULUS_TEXT (stimtext.tap)
NODE_NAMES (nodenames.tap)
EVENTS_INIT (eventsinit.tap)
PROBE_DETECTION (probedet.tap)

The required set of DTIF files that would enable the generation of probe diagnostics for a digital UUT using dynamic patterns are

HEADER (header.tap)
STIMULUS (stimulus.tap)
PO_RESPONSE (response.tap)
PI_NAMES (pinames.tap)
PO_NAMES (ponames.tap)
MAIN_MODEL (mainmodel.tap)

COMPONENT_TYPE (types.tap)
 USER_NODE (usernodes.tap)
 INPUT_PIN_NAMES (inputpins.tap)
 OUTPUT_PIN_NAMES (outputpin.tap)
 NEAR_FROMS_POINTERS (nerfrmprtr.tap)
 NEAR_FROMS (nearfroms.tap)
 EVENT (events.tap)
 SETTLED_STATE_&_PULSES (setldpuls.tap)
 NODE_SOURCE (nodsource.tap)
 STEPS (steps.tap)
 TRISTATE_FROMS_POINTERS (zfromptrs.tap)
 TRISTATE_FROMS (zfroms.tap)
 PSEUDOPI_NAMES (psupinams.tap)
 TIMING_SETS (timesets.tap)
 TIMING_PER_PATTERN (timperpat.tap)
 PHASE_CONNECTIONS (phaseconn.tap)
 AUXILIARY_PIN_NAMES (auxpins.tap)
 PI_FORMATS (piformats.tap)
 FORMAT_ATTRIBUTES (formattrs.tap)
 PROBETAG_DEFINITIONS (probetag.tap)
 PROBETAG_ASSIGNMENTS (probeasgn.tap)
 BURSTS (bursts.tap)
 STIMULUS_TEXT (stimtext.tap)
 NODE_NAMES (nodenames.tap)
 EVENTS_INIT (eventsinit.tap)
 PROBE_DETECTION (probedet.tap)

Table 1 summarizes the required set of DTIF files for the implementation of various digital test strategies.

Table 1—Conformance matrix

DTIF file name	File no.	End-to-end	End-to-end	Fault Dictionary	Fault Dictionary	Probe	Probe
		Static	Dynamic	Static	Dynamic	Static	Dynamic
header.tap	1	X	X	X	X	X	X
stimulus.tap	2	X	X	X	X	X	X
response.tap	3	X	X	X	X	X	X
pinames.tap	4	X	X	X	X	X	X
ponames.tap	5	X	X	X	X	X	X
mainmodel.tap	6			X	X	X	X
types.tap	7			X	X	X	X
usernodes.tap	8			X	X	X	X
inputpins.tap	9			X	X	X	X
outputpin.tap	10			X	X	X	X
nerfrmpttr.tap	11					X	X
nearfroms.tap	12					X	X
events.tap	13					X	X
setldonly.tap	14					X	
setldpuls.tap	15						X
nodsource.tap	16					X	X
steps.tap	17					X	X
fdpopats.tap	18			X			
fdfltsig.tap	19			X			
fdprint.tap	20			X			
zfromptrs.tap	21					X	X
zfroms.tap	22					X	X
psupinams.tap	23			X		X	X
timesets.tap	24		X				X
timperpat.tap	25	X	X	X		X	X
phaseconn.tap	26		X		X		X
auxpins.tap	27			X	X	X	X
piformats.tap	28		X		X		X
formattrrs.tap	29		X		X		X
fdxref.tap	30			X	X		
probetag.tap	31					X	X
probeasgn.tap	32					X	X
bursts.tap	33	X	X	X	X	X	X
stimtext.tap	34	X	X	X	X	X	X
nodenames.tap	35			X	X	X	X
eventsinit.tap	36					X	X
equivflts.tap	37			X	X		
probedet.tap	38					X	X
fdeqvs.tap	39			X	X		

Annex A

(informative)

Implementation overview

Test data generated must be linked to a target tester in order to perform a test on a given UUT. This annex describes various software elements, which are utilized in an application development environment to meet the target tester input data requirements. There are two environments, the application development environment and the ATE environment, which are shown in Figure A.1.

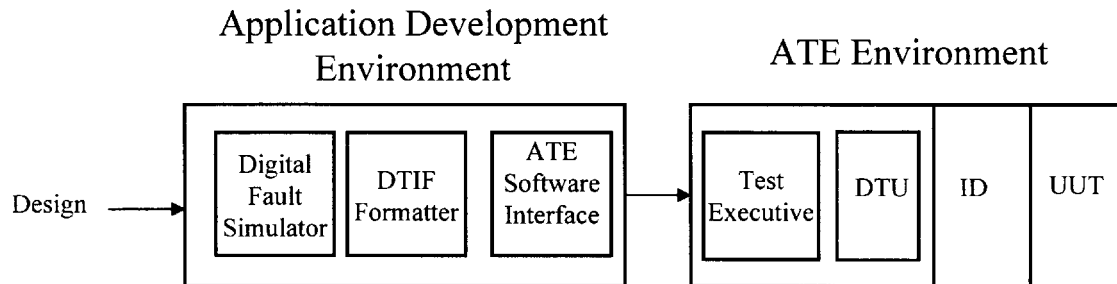


Figure A.1 — Software elements of a test environment

A.1 Application development environment

A.1.1 Digital fault simulator

A system that predicts the behavior of a digital circuit under good and faulty conditions via a set of software programs. It utilizes component software models to create a circuit connectivity model. A set of input stimuli and a corresponding set of responses are generated for good circuit and faulty circuit performance. Fault detection and isolation data are established using the simulator's internal format.

A.1.2 DTIF formatter

The DTIF formatter is the software that converts non-standard test data, usually from the DATPG, into the DTIF format.

A.1.3 ATE Software interface

Software required to link the DTIF data to the target tester. It may include the following:

- A tester peculiar language which describes test strategy for a given UUT and to which any other required data can be linked.
- A way to create a tester environment (e.g., UUT/ID I/O pin mapping, UUT/ATE timing data considerations, etc.).
- A processor to convert the DTIF data into source data for the target tester.

A.2 ATE environment

A.2.1 Test executive

The test executive is the set of core software routines that access the ATE hardware.

A.2.2 Digital test unit (DTU)

The DTU is the specific hardware for applying and measuring digital test patterns.

A.2.3 Interface device (ID)

The ID is the hardware necessary to interlace the ATE interface to the UUT interface.

A.2.4 Unit under test (UUT)

The UUT is the device being tested.

Annex B

(informative)

DTIF dependency diagrams

The purpose of the dependency diagrams is to show the interrelationship and dependency of the files. There are four dependency diagrams (Figures B.2 through B.5) representing the following groups of files:

- a) Model;
- b) Stimulus and Response;
- c) Fault dictionary;
- d) Probe.

In all diagrams, the arrows represent pointers or dependency of files. A file that “points to” another file, “depends on” the information contained in that file. The dashed lines and dashed boxes represent a dependency to a file in another functional group. The only connection of lines is when the same file points to a series of other files. Therefore, there are no lines from two or more different files interconnecting to point to one file (see Figure B.1).



Figure B.1 — File connection description

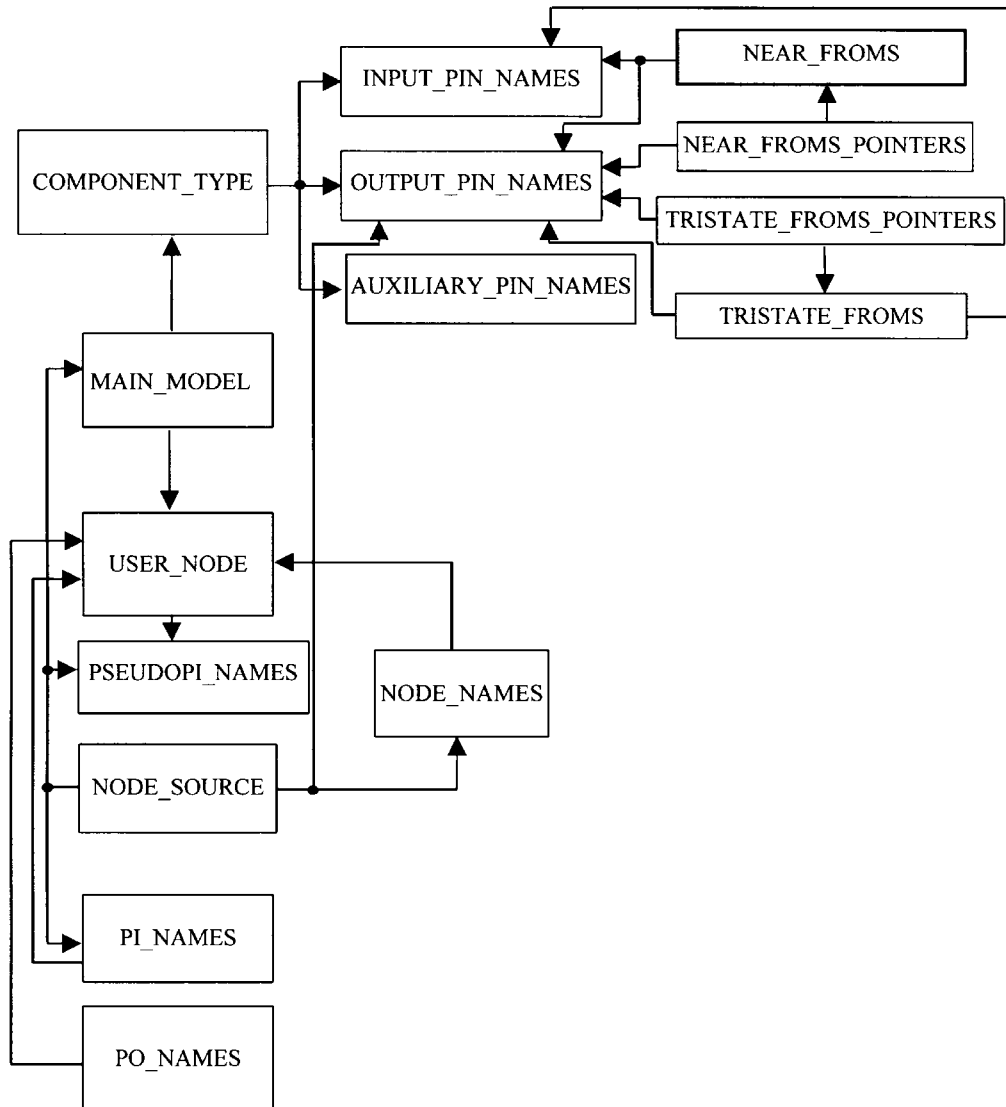


Figure B.2—UUT Model Group dependency diagram

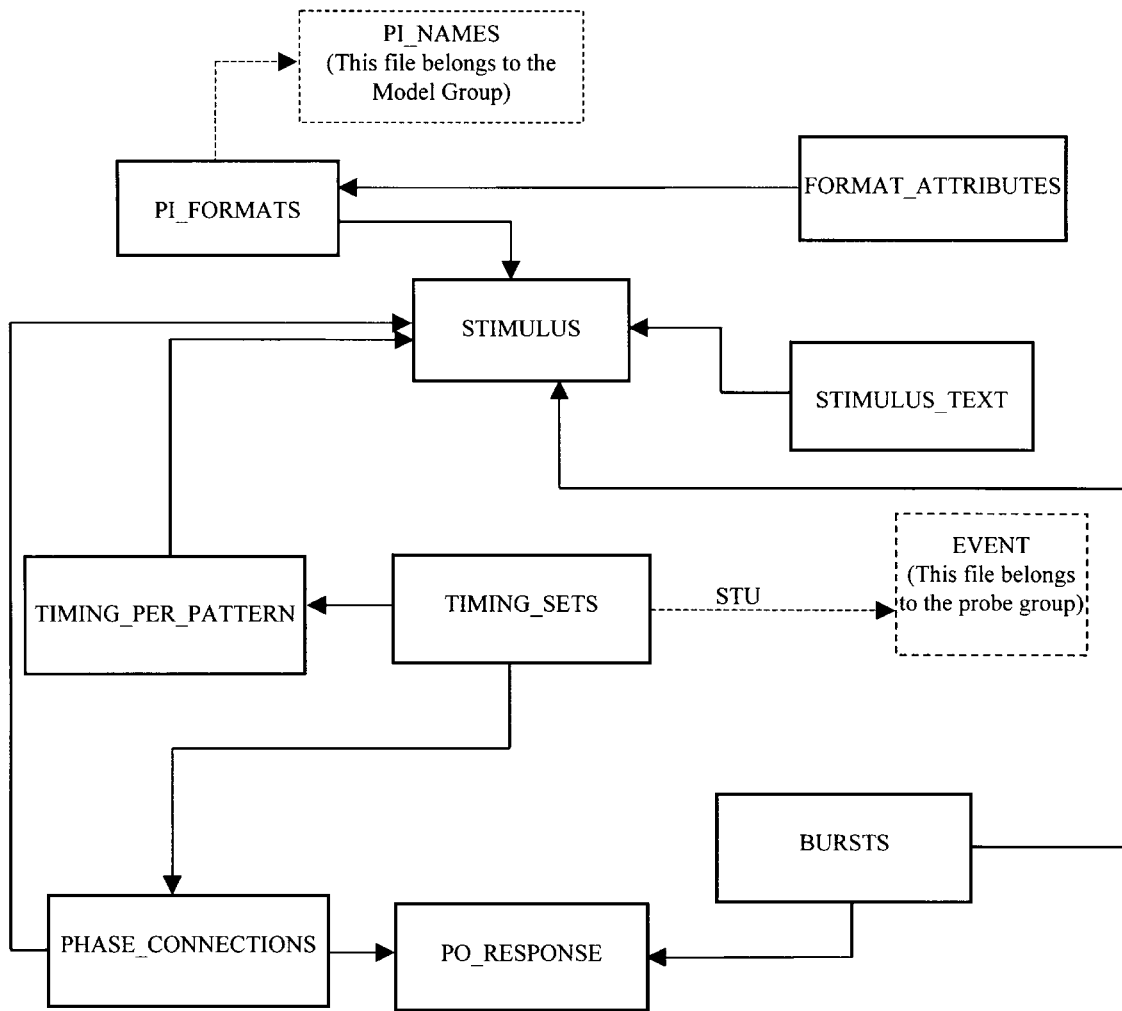
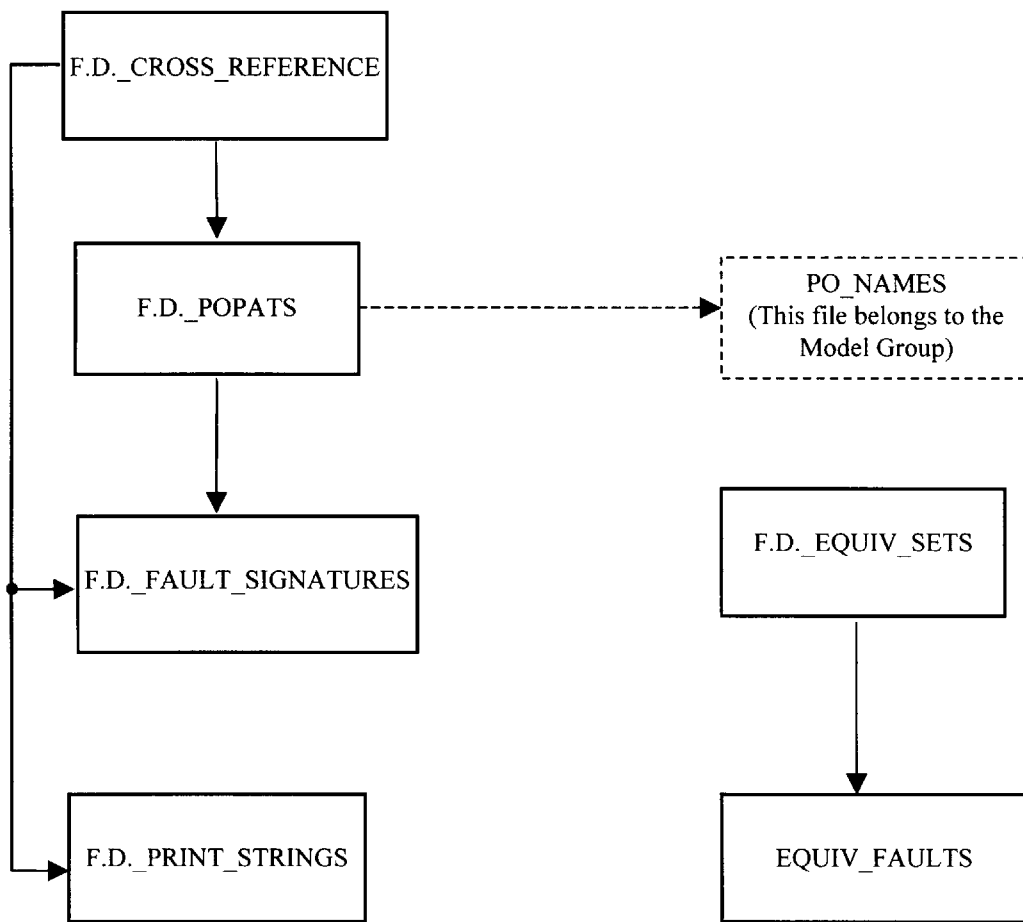


Figure B.3—Stimulus and Response Group dependency diagram



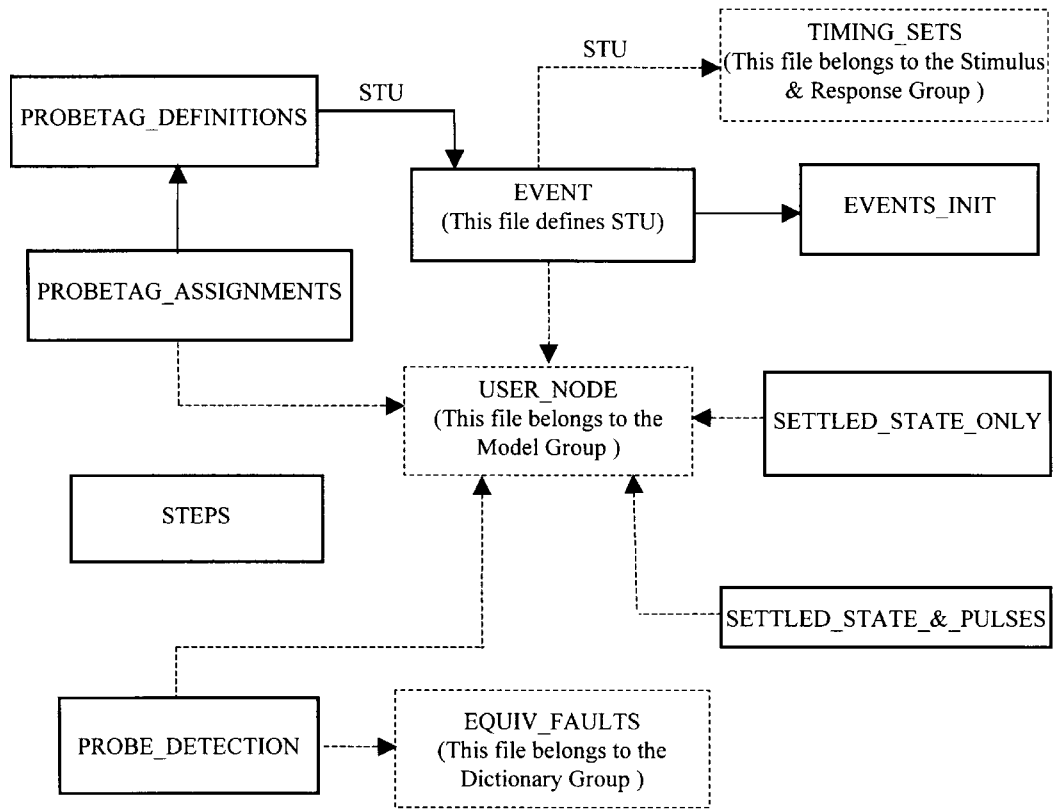


Figure B.5—Probe Group dependency diagram

Annex C

(informative)

Example circuit

Figure C.1 is the schematic of the circuit used in a test simulation. A complete set of input source files and the resultant DTIF compliant output file listings are provided for this circuit. The DTIF compliant output files may be generated by a variety of DATPGs. This example employed LASAR as the DATPG in producing these files. The LASAR simulation input files necessary to produce all 39 of the DTIF files are listed in C.1. The DTIF files are listed in C.2.

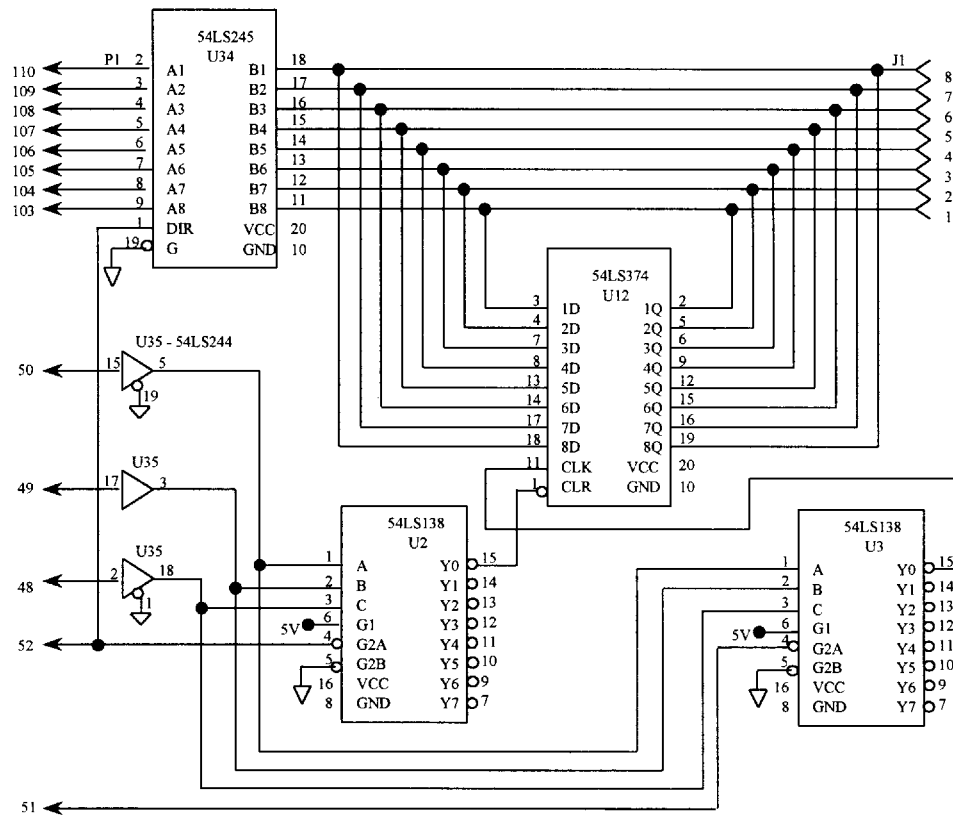


Figure C.1—Example circuit used in a test simulation

C.1 Input source files

C.1.1 Batch.com

This file runs all the LASAR commands in a batch mode.

```
$ LASAR
  COMPIL MODEL EXAMPLE.NET
  COMPIL FAULTLIST FAULTPIN.FLT
  COMPIL STIMULUS STIM.PAT
  SIMULATE
  JUDGE/NODROP_POSSIBLE_DETECTS/PROBE_DATA/FAULT_DICTIONARY
```

```
GENERATE FAULT_DICTIONARY
COMPILE PROBESPECS
POSTPROCESS LSRTAP/DIAGNOSE=TR,FA/PROBE_FILES/EQUIVALENT_FAULTS/WIZARD
$ EXIT
```

C.1.2 Example.net

This file is the netlist for the example circuit.

```
MODULE NAME = 'EXAMPLE';
!
DECLARATION SECTION;
!
DECLARE AS $LOG_0 NODE 'GND';
DECLARE AS $LOG_1 NODE 'VCC';
!
END_DECLARATIONS;
!
COMPONENT SECTION;
!
U2 = SN74LS138;
U3 = SN74LS138;
U12 = SN54LS374;
U34 = SN54LS245;
U35 = SN54LS244;
!
END_COMPONENT;
!
NODE SECTION;
!
@GND, U34-19, U35-1, U35-19, U2-5, U3-5;
!
@VCC, U2-6, U3-6;
! PRIMARY INPUTS
PI P1_50, U35-15;
PI P1_49, U35-17;
PI P1_48, U35-2;
PI P1_52, U2-4, U34-1;
PI P1_51, U3-4;
! BIDIRECTIONALS
BI J1_8, U34-18, U12-19, U12-18;
BI J1_7, U34-17, U12-16, U12-17;
BI J1_6, U34-16, U12-15, U12-14;
BI J1_5, U34-15, U12-12, U12-13;
BI J1_4, U34-14, U12-9, U12-8;
BI J1_3, U34-13, U12-6, U12-7;
BI J1_2, U34-12, U12-5, U12-4;
BI J1_1, U34-11, U12-2, U12-3;
BI P1_110, U34-2;
BI P1_109, U34-3;
BI P1_108, U34-4;
BI P1_107, U34-5;
BI P1_106, U34-6;
BI P1_105, U34-7;
BI P1_104, U34-8;
BI P1_103, U34-9;
! INTERNAL SIGNALS
U35-5, U2-1, U3-1;
U35-3, U2-2, U3-2;
U35-18, U2-3, U3-3;
U2-15, U12-1;
U3-15, U12-11;
!
```

```
END_NODE;
!
END_MODULE;
```

C.1.3 Faultpin.flt

This file lists all the fault types to be observed.

```
SWITCHES;
    EQUIVALENCING=INTERNAL;
    PREDETECTION=ON;
    SAMPLING=OFF;
    REPORT=NONE;
ENDSWITCHES;
INSERT NONPRIMITIVE OUTPUTS STUCK, INPUTS OPEN;
INSERT PIs STUCK;
INSERT POs STUCK;
```

C.1.4 Stim.pat

This file is the static stimulus for the example circuit.

```
INCLUDE 'TIMING.PAT'
!
DECLARATIONS
    GROUPNAME DBUS FOR P1_110 P1_109 P1_108 P1_107 P1_106 P1_105 P1_104 P1_103
    GROUPNAME JBUS FOR J1_8 J1_7 J1_6 J1_5 J1_4 J1_3 J1_2 J1_1
ENDDECLARATIONS
!
.NOBFR
H INPUTS L P1_51 P1_50 P1_49 P1_48 OFF JBUS !INITIALIZE THE UUT
MSG '          Verify DBUS through J1_8 - J1_1'
L P1_110 P1_108 P1_106 P1_104 !VERIFY DBUS THROUGH JBUS - NO SHORTS
H P1_110 P1_108 P1_106 P1_104 !VERIFY DBUS THROUGH JBUS - NO SHORTS
L P1_109 P1_107 P1_105 P1_103 !VERIFY DBUS THROUGH JBUS - NO SHORTS
H P1_109 P1_107 P1_105 P1_103 !VERIFY DBUS THROUGH JBUS - NO SHORTS
OFF DBUS !GET U34 READY TO READ
H JBUS !PLACE A HI ON THE JBUS TO CLOCK INTO U12
L P1_52 !CHANGE DIRECTION ON U34 (B->A) AND ENABLE THE OUTPUT ON U12
MSG '          Clock U12'
H P1_51 !CLOCK U12
L P1_51 !CLOCK U12
OFF JBUS !READ DATA FROM U12 OUT THROUGH DBUS
H P1_52 !CHANGE DIRECTION ON U34 (A->B) AND DISABLE THE OUTPUT ON U12
L JBUS !PLACE A LO ON THE JBUS TO CLOCK INTO U12
L P1_52 !CHANGE DIRECTION ON U34 (B->A) AND ENABLE THE OUTPUT ON U12
MSG '          Verify data through the DBUS'
MSG '          Clock U12'
H P1_51 !CLOCK U12
L P1_51 !CLOCK U12
OFF JBUS !READ DATA FROM U12 OUT THROUGH DBUS
H P1_52 !CHANGE DIRECTION ON U34 (A->B) AND DISABLE THE OUTPUT ON U12
H J1_8 J1_6 J1_4 J1_2 L J1_7 J1_5 J1_3 J1_1 !VERIFY NO SHORTS EXIST ON THE JBUS AND U12
L P1_52 !CHANGE DIRECTION ON U34 (B->A) AND ENABLE THE OUTPUT ON U12
MSG '          Verify data through the DBUS'
MSG '          Clock U12'
H P1_51 !CLOCK U12
L P1_51 !CLOCK U12
OFF JBUS !READ DATA FROM U12 OUT THROUGH DBUS
H P1_52 !CHANGE DIRECTION ON U34 (A->B) AND DISABLE THE OUTPUT ON U12
!STIMULUS USED TO GENERATE 'TAP' FILES ASSOCIATED WITH DYNAMIC STIMULUS
.BFR
HIGHSPEED
USE TSET 1
CPP = 1
```

```
L P1_110 P1_109 P1_108 P1_107 P1_106 P1_105 P1_104 P1_103;
H P1_110 P1_109 P1_108 P1_107 P1_106 P1_105 P1_104 P1_103;
!
END
```

C.1.5 Timing.pat

This file lists the dynamic stimulus for the example circuit.

```
SET TSET 1 CLOCK = 300NS
  PHASE 1 ASSERT = 0NS RETURN = 285NS
  WINDOW 1 OPEN = 200NS CLOSE = 220NS;
```

```
SET DIGITAL (P1_110)
  PHASE = 1
  FORMAT = $NRET;
```

```
SET DIGITAL (P1_109)
  PHASE = 1
  FORMAT = $NRET;
```

```
SET DIGITAL (P1_108)
  PHASE = 1
  FORMAT = $NRET;
```

```
SET DIGITAL (P1_107)
  PHASE = 1
  FORMAT = $NRET;
```

```
SET DIGITAL (P1_106)
  PHASE = 1
  FORMAT = $NRET;
```

```
SET DIGITAL (P1_105)
  PHASE = 1
  FORMAT = $NRET;
```

```
SET DIGITAL (P1_104)
  PHASE = 1
  FORMAT = $NRET;
```

```
SET DIGITAL (P1_103)
  PHASE = 1
  FORMAT = $NRET;
```

```
SET DIGITAL (J1_8)
  PHASE = 1
  FORMAT = $NRET;
```

```
SET DIGITAL (J1_7)
  PHASE = 1
  FORMAT = $NRET;
```

```
SET DIGITAL (J1_6)
  PHASE = 1
  FORMAT = $NRET;
```

```
SET DIGITAL (J1_5)
  PHASE = 1
  FORMAT = $NRET;
```

```
SET DIGITAL (J1_4)
  PHASE = 1
  FORMAT = $NRET;
```

```
SET DIGITAL (J1_3)
  PHASE = 1
  FORMAT = $NRET;

SET DIGITAL (J1_2)
  PHASE = 1
  FORMAT = $NRET;

SET DIGITAL (J1_1)
  PHASE = 1
  FORMAT = $NRET;

SET DIGITAL (P1_50)
  PHASE = 1
  FORMAT = $NRET;

SET DIGITAL (P1_49)
  PHASE = 1
  FORMAT = $NRET;

SET DIGITAL (P1_48)
  PHASE = 1
  FORMAT = $NRET;

SET DIGITAL (P1_52)
  PHASE = 1
  FORMAT = $NRET;

SET DIGITAL (P1_51)
  PHASE = 1
  FORMAT = $NRET;

SET PHASE 1 TRIGGER = $T0CLK;

SET DIGITAL (P1_110.)
  WINDOW = 1;

SET DIGITAL (P1_109.)
  WINDOW = 1;

SET DIGITAL (P1_108.)
  WINDOW = 1;

SET DIGITAL (P1_107.)
  WINDOW = 1;

SET DIGITAL (P1_106.)
  WINDOW = 1;

SET DIGITAL (P1_105.)
  WINDOW = 1;

SET DIGITAL (P1_104.)
  WINDOW = 1;

SET DIGITAL (P1_103.)
  WINDOW = 1;

SET DIGITAL (J1_8.)
  WINDOW = 1;

SET DIGITAL (J1_7.)
  WINDOW = 1;
```

```
SET DIGITAL (J1_6.)  
  WINDOW = 1;  
  
SET DIGITAL (J1_5.)  
  WINDOW = 1;  
  
SET DIGITAL (J1_4.)  
  WINDOW = 1;  
  
SET DIGITAL (J1_3.)  
  WINDOW = 1;  
  
SET DIGITAL (J1_2.)  
  WINDOW = 1;  
  
SET DIGITAL (J1_1.)  
  WINDOW = 1;
```

C.2 Resultant DTIF compliant output files

C.2.1 HEADER file

HEADER	1	3EXAMPLE	5-DEC-1997 10:03
5-DEC-1997		MODEL COMPILATION DATE	
21		NUMBER OF PI'S	
16		NUMBER OF PO'S	
29		NUMBER OF PATTERNS	
21		NUMBER OF PACKAGES	
21		HIGHEST USER COMPONENT NUMBER	
6		NUMBER OF COMPONENT TYPES	
		(NO LONGER IN USE)	
		(NO LONGER IN USE)	
16		NUMBER OF WIRED NETS	
76		NUMBER OF USER NODES	
105		HIGHEST USER NODE NUMBER	
38		NUMBER OF FILES ON THIS TAPE	
159		NUMBER OF FAULTS CONSIDERED (FD ONLY)	
121		NUMBER OF FAULTS DEFINITELY DETECTED (FD ONLY)	
32		NUMBER OF FAULTS POSSIBLY DETECTED (FD ONLY)	
10		PATTERN DETECTION LIMIT (FD ONLY)	
		(SPARE)	
		(SPARE)	
		(SPARE)	
		(SPARE)	
		(SPARE)	
		(SPARE)	
		(SPARE)	
		(SPARE)	
		(SPARE)	
		(SPARE)	
HEADER	1		
STIMULUS	2		
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PI_NAMES	4		
PO_NAMES	5		
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C.2.2 STIMULUS file

STIMULUS	2	2EXAMPLE	5-DEC-1997 10:03
21 29	1	29	
4444444444444444444444444444			
3334344444444444444444444444			
3334322222222224444444444444			
3334322222222223434343434			
3334322222222224444444444444			
3334322222222224343434343			
3334322222222224444444444444			
3334322222222222222222222222			
3334344444444422222222222222			
3333344444444422222222222222			
3333444444444422222222222222			
3333344444444422222222222222			
3333322222222222222222222222			
3334322222222222222222222222			
3334333333333222222222222222			
3333333333333222222222222222			
3333433333333222222222222222			
3333333333333222222222222222			
3333322222222222222222222222			
3334322222222222222222222222			
3334342424242222222222222222			
3334343434343222222222222222			
3333343434343222222222222222			
3333443434343222222222222222			
3333343434343222222222222222			
3333322222222222222222222222			
3334322222222222222222222222			
3334322222222223333333333			
3334322222222224444444444			

C.2.3 PO_RESPONSE file

PO_RESPONSE	3	2EXAMPLE	5-DEC-1997 10:03
16	29	1	29

44444444444444444444
44444444444444444444
44444444444444444444
3434343434343434
44444444444444444444
4343434343434343
44444444444444444444
1111111122222222
4444444422222222
44444444444444444444
44444444444444444444
44444444444444444444
44444444444444444444
1111111122222222
3333333322222222
3333333333333333
3333333333333333
3333333333333333
3333333333333333
1111111122222222
4141414122222222
4343434322222222
4343434343434343
4343434343434343
4343434343434343
4343434343434343
1111111122222222
3333333333333333
4444444444444444

C.2.4 PI_NAMES file

PI_NAMES	4	2EXAMPLE	5-DEC-1997 10:03
21 17			

P1_50 1 0
P1_49 2 0
P1_48 3 0
P1_52 4 0
P1_51 5 0
J1_8 6 1
J1_7 7 2
J1_6 8 3
J1_5 9 4
J1_4 10 5
J1_3 11 6
J1_2 12 7
J1_1 13 8
P1_110 14 9
P1_109 15 10
P1_108 16 11
P1_107 17 12
P1_106 18 13
P1_105 19 14
P1_104 20 15
P1_103 21 16

C.2.5 PO_NAMES file

PO_NAMES	5	2EXAMPLE	5-DEC-1997 10:03
16 17			
J1_8.	80	1	
J1_7.	81	2	
J1_6.	82	3	
J1_5.	83	4	
J1_4.	84	5	
J1_3.	85	6	
J1_2.	86	7	
J1_1.	87	8	
P1_110.	88	9	
P1_109.	89	10	
P1_108.	90	11	
P1_107.	91	12	
P1_106.	92	13	
P1_105.	93	14	
P1_104.	94	15	
P1_103.	95	16	

C.2.6 MAIN_MODEL file

MAIN_MODEL	6	2EXAMPLE	5-DEC-1997 10:03
21			
U2	1	6 8 1 7	1
U3	1	6 8 15 21	2
U12	2	10 8 29 39	3
U34	3	2 16 47 49	4
U35	4	10 8 65 75	5
WN\$ _1	5	3 1 83 86	6
WN\$ _2	5	3 1 87 90	7
WN\$ _3	5	3 1 91 94	8
WN\$ _4	5	3 1 95 98	9
WN\$ _5	5	3 1 99 102	10
WN\$ _6	5	3 1 103 106	11
WN\$ _7	5	3 1 107 110	12
WN\$ _8	5	3 1 111 114	13
WN\$ _9	6	2 1 115 117	14
WN\$ _10	6	2 1 118 120	15
WN\$ _11	6	2 1 121 123	16
WN\$ _12	6	2 1 124 126	17
WN\$ _13	6	2 1 127 129	18
WN\$ _14	6	2 1 130 132	19
WN\$ _15	6	2 1 133 135	20
WN\$ _16	6	2 1 136 138	21

C.2.7 COMPONENT_TYPE file

COMPONENT_TYPE	7	4EXAMPLE	5-DEC-1997 10:03
6			
SN74LS138	6	8 1 1 1	1
SN54LS374	10	8 7 9 2	2
SN54LS245	2	16 17 17 3	3
SN54LS244	10	8 19 33 4	4
WN _3	3	1 29 41 5W	
WN _2	2	1 32 42 6W	

C.2.8 USER_NODE file

USER_NODE		8	2EXAMPLE		5-DEC-1997 10:03			
105	18							
78	79	72	105	4	104	32	33	
34	35	36	37	38	39	78	79	
72	105	5	104	40	41	42	43	
44	45	46	47	32	87	86	85	
84	83	82	81	80	40	48	49	
50	51	52	53	54	55	4	104	
56	57	58	59	60	61	62	63	
64	65	66	67	68	69	70	71	
104	3	100	100	100	104	100	100	
1	2	72	73	74	75	76	77	
78	79	6	71	55	80	7	70	
54	81	8	69	53	82	9	68	
52	83	10	67	51	84	11	66	
50	85	12	65	49	86	13	64	
48	87	14	56	88	15	57	89	
16	58	90	17	59	91	18	60	
92	19	61	93	20	62	94	21	
63	95							

C.2.9 INPUT_PIN_NAMES file

INPUT_PIN_NAMES		9	2EXAMPLE		5-DEC-1997 10:03			
33	7							
1		2		3		6	4	
5		1		3		4	7	
8		13		14		17	18	
11		1		19		1	2	
4		6		8		19	11	
13		15		17		\$1	\$2	
\$3		\$1		\$2				

C.2.10 OUTPUT_PIN_NAMES file

OUTPUT_PIN_NAMES		10	2EXAMPLE		5-DEC-1997 10:03			
42	9							
15		14		13		12	11	
10		9		7		2	5	
6		9		12		15	16	
19		2		3		4	5	
6		7		8		9	11	
12		13		14		15	16	
17		18		18		16	14	
12		9		7		5	3	
OUT		OUT						

C.2.11 NEAR_FROMS_POINTERS file

NEAR_FROMS_POINTERS				11	2EXAMPLE				5-DEC-1997 10:03						
6	1	6	7	6	13	6	19	6	25	6	31	6	37	6	43
3	49	3	52	3	55	3	58	3	61	3	64	3	67	3	70
3	73	3	76	3	79	3	82	3	85	3	88	3	91	3	94
3	97	3	100	3	103	3	106	3	109	3	112	3	115	3	118
2	121	2	123	2	125	2	127	2	129	2	131	2	133	2	135
3	137	2	140												

C.2.12 NEAR_FROMS file

```
NEAR_FROMS          12  2EXAMPLE          5-DEC-1997 10:03
 1  2  3  5  6  4  2  3  5  6  1  4  1  3  5  6  2  4  3  5
 6  1  2  4  1  2  5  6  3  4  2  5  6  3  1  4  1  5  6  3
 2  4  5  6  4  2  1  3  1  2  10  1  3  10  1  4  10  1  5  10
 1  6  10  1  7  10  1  8  10  1  9  10 -16  2  1 -15  2  1 -14  2
 1 -13  2  1 -12  2  1 -11  2  1 -10  2  1 -9  2  1  1 -8  2  1
-7  2  1 -6  2  1 -5  2  1 -4  2  1 -3  2  1 -2  2  1 -1  2
 2  1  3  1  4  1  5  1  7  6  8  6  9  6  10  6  1  2  3  1
 2
```

C.2.13 EVENT file

```
EVENT          13  2EXAMPLE          5-DEC-1997 10:03
 1 -12
0C1H2H3H4H5H6H7H8H9H10H11H12H13H14H15H16H17H18H19H20H21H10C88H89H90H91H92H93H94H
95H7528A32H33H34H35H36H37H38H39H40H41H42H43H44H45H46H47H462A72H78H79H10A64H65H66
H67H68H69H70H71H10A80H81H82H83H84H85H86H87H980A56K57K58K59K60K61K62K63K6574A48K4
9K50K51K52K53K54K55K2426C72H78H79H10C64H65H66H67H68H69H70H71H10C80H81H82H83H84H8
5H86H87H7980C32H33H34H35H36H37H38H39H40H41H42H43H44H45H46H47H2000C56K57K58K59K60
K61K62K63K18000C48K49K50K51K52K53K54K55K46001@1P0C1E2E3E5E4447A47E3553A72E78E79E
1261C47N8739C72E78E79E260A40E41N42N43N44N45N46N6070A47HB41H42H43H44H45H46H13670D
47E6999D41N42N43N44N45N46N1C41H42H43H44H45H46H47H12000C40E57001@2P0C6K7K8K9K10K1
1K12K13K1@3P0C14E16E18E20E10C88E90E92E94E8000A65E67E69E71E10A80E82E84E86E9990C65
E67E69E71E10C80E82E84E86E18021@4P0C14H16H18H20H10C88H90H92H94H8000A65H67H69H71H1
0A80H82H84H86H9990C65H67H69H71H10C80H82H84H86H18021@5P0C15E17E19E21E10C89E91E93E
95E8000A64E66E68E70E10A81E83E85E87E9990C64E66E68E70E10C81E83E85E87E18021@6P0C15H
17H19H21H10C89H91H93H95H8000A64H66H68H70H10A81H83H85H87H9990C64H66H68H70H10C81H8
3H85H87H18021@7P0C14K15K16K17K18K19K20K21K10C88K89K90K91K92K93K94K95K8000A64N65N
66N67N68N69N70N71N10A80N81N82N83N84N85N86N87N9990C64N65N66N67N68N69N70N71N10C80N
81N82N83N84N85N86N87N18021@8P0C6H7H8H9H10H11H12H13H10C80H81H82H83H84H85H86H87H11
@9P0C4E4447A32E4553A64K65K66K67K68K69K70K71K6630A56H57H58H59H60H61H62H63H10A88H8
9H90H91H92H93H94H95H4197A48N49N50N51N52N53N54N55N8163C64K65K66K67K68K69K70K71K10
000C32E2000C56H57H58H59H60H61H62H63H10C88H89H90H91H92H93H94H95H25990C48N49N50N51
N52N53N54N55N6001@10P0C5H7538A40H8036A48H49H50H51H52H53H54H55H10426C40H28000C48
H49H50H51H52H53H54H55H54001@11P0C5E4447A40E33553C40E38001@12P0C6K7K8K9K10K11K12K
13K1@13P0C4H7538A32H498A56K57K58K59K60K61K62K63K10A88K89K90K91K92K93K94K95K7528A
48K49K50K51K52K53K54K55K10A80K81K82K83K84K85K86K87K46A64N65N66N67N68N69N70N71N10
B80N81N82N83N84N85N86N87N10360C32H2000C56K57K58K59K60K61K62K63K10C88K89K90K91K92
K93K94K95K11990C64N65N66N67N68N69N70N71N10C80N81N82N83N84N85N86N87N13990C48K49K5
0K51K52K53K54K55K54001@14P0C6E7E8E9E10E11E12E13E10C80E81E82E83E84E85E86E87E11@15
P0C4E4447A32E4553A64K65K66K67K68K69K70K71K9230A56E57E58E59E60E61E62E63E10A88E89E
90E91E92E93E94E95E1597A48H49H50H51H52H53H54H55H8163C64K65K66K67K68K69K70K71K1000
0C32E2000C56E57E58E59E60E61E62E63E10C88E89E90E91E92E93E94E95E23990C48H49H50H51H5
2H53H54H55H64001@16P0C5H7538A40H12890A48E49E50E51E52E53E54E55E572C40H28000C48E4
9E50E51E52E53E54E55E54001@17P0C5E4447A40E33553C40E38001@18P0C6K7K8K9K10K11K12K13
K1@19P0C4H7538A32H1462A56K57K58K59K60K61K62K63K10A88K89K90K91K92K93K94K95K7528A4
8K49K50K51K52K53K54K55K10A80K81K82K83K84K85K86K87K2262A64N65N66N67N68N69N70N71N1
0B80N81N82N83N84N85N86N87N7980C56K57K58K59K60K61K62K63K10C88K89K90K91K92K93K94K9
5K990C32H17010C64N65N66N67N68N69N70N71N10C80N81N82N83N84N85N86N87N2980C48K49K50K
51K52K53K54K55K46001@20P0C6H8H10H12H10C80H82H84H86H11@21P0C7E9E11E13E10C81E83E85
E87E11@22P0C4E4447A32E4553A64K65K66K67K68K69K70K71K6630A56H58H60H62H10A88H90H92H
94H2590A57E59E61E63E10A89E91E93E95E1957A48E49E50E51E52E53E54E55E7803C64K65K66K67
K68K69K70K71K10000C32E2000C56H57E58H59E60H61E62H63E10C88H89E90H91E92H93E94H95E25
990C48E49E50E51E52E53E54E55E66001@23P0C5H7538A40H8036A49H51H53H55H10426C40H28000
C49H51H53H55H54001@24P0C5E4447A40E33553C40E38001@25P0C6K7K8K9K10K11K12K13K1@26P0
C4H7538A32H498A56K58K60K62K10A88K90K92K94K95A57K59K61K63K10A89K91K93K95K7528A48
K50K52K54K10A81K83K85K87K826A49K51K53K55K10A80K82K84K86K46A65N67N69N71N10B80N82N
84N86N1370A64N66N68N70N10B81N83N85N87N7980C57K59K61K63K10C89K91K93K95K990C32H200
0C56K58K60K62K10C88K90K92K94K11990C65N67N69N71N10C80N82N84N86N3000C64N66N68N70N1
0C81N83N85N87N2980C48K50K52K54K8000C49K51K53K55K54001@27P1Q0C14E15E16E17E18E19E2
0E21E10C88E89E90E91E92E93E94E95E8000A64E65E66E67E68E69E70E71E10A80E81E82E83E84E8
```

5E86E87E9990C64E65E66E67E68E69E70E71E10C80E81E82E83E84E85E86E87E300000@28P0C14H1
5H16H17H18H19H20H21H10C88H89H90H91H92H93H94H95H8000A64H65H66H67H68H69H70H71H10A8
0H81H82H83H84H85H86H87H9990C64H65H66H67H68H69H70H71H10C80H81H82H83H84H85H86H87H3
00000@29P2QR

C.2.14 SETTLED_STATE_ONLY file

```
SETTLED_STATE_ONLY      14      2EXAMPLE      5-DEC-1997 10:03
*9*2.16 48 49 50 51 52 53 54 55 56 57 58 59 60 61 62 63*4.69 1 2 3 4 5 6 7 8 9 1
0 11 12 13 14 15 16 17 18 19 20 21 32 33 34 35 36 37 38 39 40 41 42 43 44 45 46
47 64 65 66 67 68 69 70 71 72 73 74 75 76 77 78 79 80 81 82 83 84 85 86 87 88 89
90 91 92 93 94 95*8*3.8 1 2 3 5 40 72 78 79*8*2.8 6 7 8 9 10 11 12 13*8*3.16 14
16 18 20 65 67 69 71 80 82 84 86 88 90 92 94*8*4.16 14 16 18 20 65 67 69 71 80
82 84 86 88 90 92 94*8*3.16 15 17 19 21 64 66 68 70 81 83 85 87 89 91 93 95*8*4.
16 15 17 19 21 64 66 68 70 81 83 85 87 89 91 93 95*8*1.16 64 65 66 67 68 69 70 7
1 80 81 82 83 84 85 86 87*2.16 14 15 16 17 18 19 20 21 88 89 90 91 92 93 94 95*8
*4.16 6 7 8 9 10 11 12 13 80 81 82 83 84 85 86 87*8*1.8 48 49 50 51 52 53 54 55*
2.8 64 65 66 67 68 69 70 71*3.2 4 32*4.16 56 57 58 59 60 61 62 63 88 89 90 91 92
93 94 95*8*4.10 5 40 48 49 50 51 52 53 54 55*8*3.2 5 40*8*2.8 6 7 8 9 10 11 12
13*8*1.16 64 65 66 67 68 69 70 71 80 81 82 83 84 85 86 87*2.24 48 49 50 51 52 53
54 55 56 57 58 59 60 61 62 63 88 89 90 91 92 93 94 95*4.2 4 32*8*3.16 6 7 8 9 1
0 11 12 13 80 81 82 83 84 85 86 87*8*2.8 64 65 66 67 68 69 70 71*3.18 4 32 56 57
58 59 60 61 62 63 88 89 90 91 92 93 94 95*4.8 48 49 50 51 52 53 54 55*8*3.8 48
49 50 51 52 53 54 55*4.2 5 40*8*3.2 5 40*8*2.8 6 7 8 9 10 11 12 13*8*1.16 64 65
66 67 68 69 70 71 80 81 82 83 84 85 86 87*2.24 48 49 50 51 52 53 54 55 56 57 58
59 60 61 62 63 88 89 90 91 92 93 94 95*4.2 4 32*8*4.8 6 8 10 12 80 82 84 86*8*3.
8 7 9 11 13 81 83 85 87*8*2.8 64 65 66 67 68 69 70 71*3.18 4 32 48 49 50 51 52 5
3 54 55 57 59 61 63 89 91 93 95*4.8 56 58 60 62 88 90 92 94*8*4.6 5 40 49 51 53
55*8*3.2 5 40*8*2.8 6 7 8 9 10 11 12 13*8*1.16 64 65 66 67 68 69 70 71 80 81 82
83 84 85 86 87*2.24 48 49 50 51 52 53 54 55 56 57 58 59 60 61 62 63 88 89 90 91
92 93 94 95*4.2 4 32*8*10*9*3.32 14 15 16 17 18 19 20 21 64 65 66 67 68 69 70 71
80 81 82 83 84 85 86 87 88 89 90 91 92 93 94 95*8*4.32 14 15 16 17 18 19 20 21
64 65 66 67 68 69 70 71 80 81 82 83 84 85 86 87 88 89 90 91 92 93 94 95*8*10*11
```

C.2.15 SETTLED_STATE_&_PULSES file

```
SETTLED_STATE_&_PULSES  15      2EXAMPLE      5-DEC-1997 10:03
10
*9*4.26 1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19 20 21 73 74 75 76 77*17.
16 48 49 50 51 52 53 54 55 56 57 58 59 60 61 62 63*19.43 32 33 34 35 36 37 38 39
40 41 42 43 44 45 46 47 64 65 66 67 68 69 70 71 72 78 79 80 81 82 83 84 85 86 8
7 88 89 90 91 92 93 94 95*8*3.8 1 2 3 5 40 72 78 79*4.32 32 33 34 35 36 37 38 39
64 65 66 67 68 69 70 71 80 81 82 83 84 85 86 87 88 89 90 91 92 93 94 95*8*4.7 4
1 42 43 44 45 46 47*17.8 6 7 8 9 10 11 12 13*8*3.16 14 16 18 20 65 67 69 71 80 8
2 84 86 88 90 92 94*8*4.16 14 16 18 20 65 67 69 71 80 82 84 86 88 90 92 94*8*3.1
6 15 17 19 21 64 66 68 70 81 83 85 87 89 91 93 95*8*4.16 15 17 19 21 64 66 68 70
81 83 85 87 89 91 93 95*8*16.16 64 65 66 67 68 69 70 71 80 81 82 83 84 85 86 87
*17.16 14 15 16 17 18 19 20 21 88 89 90 91 92 93 94 95*8*4.8 6 7 8 9 10 11 12 13
*19.8 80 81 82 83 84 85 86 87*8*3.2 4 32*4.24 56 57 58 59 60 61 62 63 80 81 82 8
3 84 85 86 87 88 89 90 91 92 93 94 95*16.8 48 49 50 51 52 53 54 55*17.8 64 65 66
67 68 69 70 71*8*4.2 5 40*19.8 48 49 50 51 52 53 54 55*8*3.2 5 40*4.8 48 49 50
51 52 53 54 55*8*17.8 6 7 8 9 10 11 12 13*8*4.2 4 32*16.16 64 65 66 67 68 69 70
71 80 81 82 83 84 85 86 87*17.24 48 49 50 51 52 53 54 55 56 57 58 59 60 61 62 63
88 89 90 91 92 93 94 95*8*3.8 6 7 8 9 10 11 12 13*18.8 80 81 82 83 84 85 86 87*
8*3.26 4 32 56 57 58 59 60 61 62 63 80 81 82 83 84 85 86 87 88 89 90 91 92 93 94
95*4.8 48 49 50 51 52 53 54 55*17.8 64 65 66 67 68 69 70 71*8*3.8 48 49 50 51 5
2 53 54 55*4.2 5 40*8*3.2 5 40*8*17.8 6 7 8 9 10 11 12 13*8*4.2 4 32*16.16 64 65
66 67 68 69 70 71 80 81 82 83 84 85 86 87*17.24 48 49 50 51 52 53 54 55 56 57 5
8 59 60 61 62 63 88 89 90 91 92 93 94 95*8*4.4 6 8 10 12*19.4 80 82 84 86*8*3.4
7 9 11 13*4.4 80 82 84 86*18.4 81 83 85 87*8*3.22 4 32 48 49 50 51 52 53 54 55 5
7 59 61 63 81 83 85 87 89 91 93 95*4.8 56 58 60 62 88 90 92 94*17.8 64 65 66 67
68 69 70 71*8*4.6 5 40 49 51 53 55*8*3.2 5 40*8*17.8 6 7 8 9 10 11 12 13*8*4.2 4
```

```

32*16.16 64 65 66 67 68 69 70 71 80 81 82 83 84 85 86 87*17.24 48 49 50 51 52 5
3 54 55 56 57 58 59 60 61 62 63 88 89 90 91 92 93 94 95*8*10*9*18.32 14 15 16 17
18 19 20 21 64 65 66 67 68 69 70 71 80 81 82 83 84 85 86 87 88 89 90 91 92 93 9
4 95*8*4.16 64 65 66 67 68 69 70 71 80 81 82 83 84 85 86 87*19.16 14 15 16 17 18
19 20 21 88 89 90 91 92 93 94 95*8*10*11

```

C.2.16 NODE_SOURCE file

```

NODE_SOURCE          16  2EXAMPLE          5-DEC-1997 10:03
105
0 1 0 2 0 3 0 4 0 5 0 6 0 7 0 8 0 9 0 10
0 11 0 12 0 13 0 14 0 15 0 16 0 17 0 18 0 19 0 20
0 21 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0
0 0 1 1 1 2 1 3 1 4 1 5 1 6 1 7 1 8 2 1
2 2 2 3 2 4 2 5 2 6 2 7 2 8 3 1 3 2 3 3
3 4 3 5 3 6 3 7 3 8 4 1 4 2 4 3 4 4 4 5
4 6 4 7 4 8 4 9 4 10 4 11 4 12 4 13 4 14 4 15
4 16 5 1 5 2 5 3 5 4 5 5 5 6 5 7 5 8 6 1
7 1 8 1 9 1 10 1 11 1 12 1 13 1 14 1 15 1 16 1
17 1 18 1 19 1 20 1 21 1 0 23 0 25 0 26 0 27 0 28
0 29 0 30 0 31 0 24 0 22

```

C.2.17 STEPS file

```

STEPS          17  2EXAMPLE          5-DEC-1997 10:03
10
1 -2 3 4 6 10 -11 13
16 19

```

C.2.18 F.D._POPATS file

```

F.D._POPATS          18  2EXAMPLE          5-DEC-1997 10:03
82
1 1 2 1 3 1 4 1 5 1 6 1 7 1 8 1
9 1 10 1 11 1 12 1 13 1 14 1 15 1 16 1
1 3 2 3 3 3 4 3 5 3 6 3 7 3 8 3
1 4 3 4 5 4 7 4 9 4 11 4 13 4 15 4
2 6 4 6 6 6 8 6 10 6 12 6 14 6 16 6
9 10 10 10 11 10 12 10 13 10 14 10 15 10 16 10
1 13 2 13 3 13 4 13 5 13 6 13 7 13 8 13
1 15 2 15 3 15 4 15 5 15 6 15 7 15 8 15
9 16 10 16 11 16 12 16 13 16 14 16 15 16 16 16
1 19 2 19 3 19 4 19 5 19 6 19 7 19 8 19
1 23 1 28

```

C.2.19 F.D._FAULT_SIGNATURES file

```

F.D._FAULT_SIGNATURES 19  2EXAMPLE          5-DEC-1997 10:03
94 33
48 3 1 17 41
48 3 2 18 42
48 3 3 19 43
48 3 4 20 44
48 3 5 21 45
48 3 6 22 46
48 3 7 23 47
48 3 8 24 48
56 3 9 17 41
56 3 10 18 42

```

56	3	11	19	43		
56	3	12	20	44		
56	3	13	21	45		
56	3	14	22	46		
56	3	15	23	47		
56	3	16	24	48		
-1	4	25	29	65	82	
-1	3	26	30	67		
-1	3	27	31	69		
-1	3	28	32	71		
82	3	33	37	66		
82	3	34	38	68		
82	3	35	39	70		
82	3	36	40	72		
-1	4	17	-41	-49	-81	
-1	3	18	-42	-50		
-1	3	19	-43	-51		
-1	3	20	-44	-52		
-1	3	21	-45	-53		
-1	3	22	-46	-54		
-1	3	23	-47	-55		
-1	3	24	-48	-56		
-1	4	25	-65	-73	82	
-1	3	26	-67	-75		
-1	3	27	-69	-77		
-1	3	28	-71	-79		
-1	3	33	-66	-74		
-1	3	34	-68	-76		
-1	3	35	-70	-78		
-1	3	36	-72	-80		
-1	1	41				
-1	1	42				
-1	1	43				
-1	1	44				
-1	1	45				
-1	1	46				
-1	1	47				
-1	1	48				
-1	2	-17	49			
-1	2	-18	50			
-1	2	-19	51			
-1	2	-20	52			
-1	2	-21	53			
-1	2	-22	54			
-1	2	-23	55			
-1	2	-24	56			
-1	5	25	57	65	73	82
81	4	33	58	66	74	
-1	4	26	59	67	75	
81	4	34	60	68	76	
-1	4	27	61	69	77	
81	4	35	62	70	78	
-1	4	28	63	71	79	
81	4	36	64	72	80	
-1	1	65				
-1	1	66				
-1	1	67				
-1	1	68				
-1	1	69				
-1	1	70				
-1	1	71				
-1	1	72				
-1	1	73				
-1	1	74				

-1	1	75										
-1	1	76										
-1	1	77										
-1	1	78										
-1	1	79										
-1	1	80										
-1	17	-17	-18	-19	-20	-21	-22	-23	-24	-25	-26	-27
-28	-33	-34	-35	-36	82							
-1	25	-17	-18	-19	-20	-21	-22	-23	-24	-25	-26	-27
-28	-33	-34	-35	-36	-57	-58	-59	-60	-61	-62	-63	-64
-82												
-1	4	-25	-57	73	-82							
-1	3	-26	-59	75								
-1	3	-27	-61	77								
-1	3	-28	-63	79								
-1	3	-33	-58	74								
-1	3	-34	-60	76								
-1	3	-35	-62	78								
-1	3	-36	-64	80								
-1	32	-41	-42	-43	-44	-45	-46	-47	-48	-49	-50	-51
-52	-53	-54	-55	-56	-65	-66	-67	-68	-69	-70	-71	-72
-73	-74	-75	-76	-77	-78	-79	-80					
-1	33	-17	-18	-19	-20	-21	-22	-23	-24	-25	-26	-27
-28	-33	-34	-35	-36	-41	-42	-43	-44	-45	-46	-47	-48
-65	-66	-67	-68	-69	-70	-71	-72	-82				
-1	16	-49	-50	-51	-52	-53	-54	-55	-56	-73	-74	-75
-76	-77	-78	-79	-80								
-1	33	-41	-42	-43	-44	-45	-46	-47	-48	-49	-50	-51
-52	-53	-54	-55	-56	-65	-66	-67	-68	-69	-70	-71	-72
-73	-74	-75	-76	-77	-78	-79	-80	-81				

C.2.20 F.D._PRINT_STRINGS file

```

F.D._PRINT_STRINGS      20      3EXAMPLE      5-DEC-1997 10:03
 94 12 28
 2      2
 9<^>J1_8@0
10<^>J1_8.@0
 2      2
 9<^>J1_7@0
10<^>J1_7.@0
 2      2
 9<^>J1_6@0
10<^>J1_6.@0
 2      2
 9<^>J1_5@0
10<^>J1_5.@0
 2      2
 9<^>J1_4@0
10<^>J1_4.@0
 2      2
 9<^>J1_3@0
10<^>J1_3.@0
 2      2
 9<^>J1_2@0
10<^>J1_2.@0
 2      2
 9<^>J1_1@0
10<^>J1_1.@0
 2      2
11<^>P1_110@0
12<^>P1_110.@0
 2      2

```

```

11<^>P1_109@0
12<^>P1_109.@0
 2      2
11<^>P1_108@0
12<^>P1_108.@0
 2      2
11<^>P1_107@0
12<^>P1_107.@0
 2      2
11<^>P1_106@0
12<^>P1_106.@0
 2      2
11<^>P1_105@0
12<^>P1_105.@0
 2      2
11<^>P1_104@0
12<^>P1_104.@0
 2      2
11<^>P1_103@0
12<^>P1_103.@0
 2      2
11<^>P1_110@1
12<^>P1_110.@1
 2      2
11<^>P1_108@1
12<^>P1_108.@1
 2      2
11<^>P1_106@1
12<^>P1_106.@1
 2      2
11<^>P1_104@1
12<^>P1_104.@1
 2      2
11<^>P1_109@1
12<^>P1_109.@1
 2      2
11<^>P1_107@1
12<^>P1_107.@1
 2      2
11<^>P1_105@1
12<^>P1_105.@1
 2      2
11<^>P1_103@1
12<^>P1_103.@1
 1      1
9<U34>18@0
 1      1
9<U34>17@0
 1      1
9<U34>16@0
 1      1
9<U34>15@0
 1      1
9<U34>14@0
 1      1
9<U34>13@0
 1      1
9<U34>12@0
 1      1
9<U34>11@0
 1      1
9<U34>18@1
 1      1
9<U34>16@1

```

```

1      1
9<U34>14@1
1      1
9<U34>12@1
1      1
9<U34>17@1
1      1
9<U34>15@1
1      1
9<U34>13@1
1      1
9<U34>11@1
1      1
8<U34>2@0
1      1
8<U34>3@0
1      1
8<U34>4@0
1      1
8<U34>5@0
1      1
8<U34>6@0
1      1
8<U34>7@0
1      1
8<U34>8@0
1      1
8<U34>9@0
1      1
9<U12>19@0
1      1
9<U12>16@0
1      1
9<U12>15@0
1      1
9<U12>12@0
1      1
8<U12>9@0
1      1
8<U12>6@0
1      1
8<U12>5@0
1      1
8<U12>2@0
2      2
9<^>J1_8@1
10<^>J1_8.@1
2      2
9<^>J1_7@1
10<^>J1_7.@1
2      2
9<^>J1_6@1
10<^>J1_6.@1
2      2
9<^>J1_5@1
10<^>J1_5.@1
2      2
9<^>J1_4@1
10<^>J1_4.@1
2      2
9<^>J1_3@1
10<^>J1_3.@1
2      2
9<^>J1_2@1

```

```

10<^>J1_2.@1
  2      2
9<^>J1_1@1
10<^>J1_1.@1
  1      1
8<U34>2@1
  1      1
8<U34>3@1
  1      1
8<U34>4@1
  1      1
8<U34>5@1
  1      1
8<U34>6@1
  1      1
8<U34>7@1
  1      1
8<U34>8@1
  1      1
8<U34>9@1
  1      1
9<U12>18/1
  1      1
9<U12>17/1
  1      1
9<U12>14/1
  1      1
9<U12>13/1
  1      1
8<U12>8/1
  1      1
8<U12>7/1
  1      1
8<U12>4/1
  1      1
8<U12>3/1
  1      1
10<^>P1_52@0
  1      1
8<U2>15@0
  1      1
9<U12>19@1
  1      1
9<U12>15@1
  1      1
8<U12>9@1
  1      1
8<U12>5@1
  1      1
9<U12>16@1
  1      1
9<U12>12@1
  1      1
8<U12>6@1
  1      1
8<U12>2@1
  1      1
10<^>P1_52@1
  1      1
9<U34>19/1
28      28
8<U35>1/1
9<U35>18@1
8<U35>2/1

```

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[illegible][illegible]

PSEUDOPI_NAMES	23	1EXAMPLE	5-DEC-1997 10:03
10			
\$L1	105		
\$L1B	96		
\$L0	104		
\$L0B	97		
\$LX	98		
\$LZ	99		
\$FL1	100		
\$FL0	101		
\$FLX	102		
SPWRON	103		

C.2.24 TIMING_SETS file

TIMING_SETS	24	1EXAMPLE	5-DEC-1997 10:03
32 1 16 16	1-12		
1 1 300000	1 1		
2 1 1	0	285000	
3 1 1	200000	220000	
4 1 2			

C.2.25 TIMING_PER_PATTERN file

TIMING_PER_PATTERN	25	3EXAMPLE	5-DEC-1997 10:03
1 0 0	28	1 1	30 1 1

C.2.26 PHASE_CONNECTIONS file

PHASE_CONNECTIONS	26	2EXAMPLE	5-DEC-1997 10:03
21 16 21 16			
1 1			
2 1			
3 1			
4 1			
5 1			
6 1			
7 1			
8 1			
9 1			
10 1			
11 1			
12 1			
13 1			
14 1			
15 1			
16 1			
17 1			
18 1			
19 1			
20 1			
21 1			
1 1			
2 1			
3 1			
4 1			
5 1			
6 1			
7 1			
8 1			
9 1			
10 1			
11 1			
12 1			
13 1			
14 1			
15 1			
16 1			

C.2.27 AUXILIARY_PIN_NAMES file

```
AUXILIARY_PIN_NAMES      27      1EXAMPLE      5-DEC-1997 10:03
6
1
2
3
4
5
6
```

C.2.28 PI_FORMATS file

```
PI_FORMATS                28      1EXAMPLE      5-DEC-1997 10:03
2
      1  0  0  0  0  0  0  0  0  0  0  0  0  0  0  0  0  0  0
0  0  0  0
      30  0  0  0  0  0  0  0  0  0  0  0  0  0  0  0  0  0  0
0  0  0  0
```

C.2.29 FORMAT_ATTRIBUTES file

```
FORMAT_ATTRIBUTES         29      1EXAMPLE      5-DEC-1997 10:03
5
0$NRET
1$RZERO
2$RONE
3$RCOMP
4$ROFF
```

C.2.30 F.D._CROSS_REFERENCE file

```
F.D._CROSS_REFERENCE      30      2EXAMPLE      5-DEC-1997 10:03
82      7  1  0
1      1
1      2
1      3
1      4
1      5
1      6
1      7
1      8
1      9
1     10
1     11
1     12
1     13
1     14
1     15
1     16
7      1      9     25    -81    -82    -49    -92
7      2     10     26    -81    -82    -50    -92
7      3     11     27    -81    -82    -51    -92
7      4     12     28    -81    -82    -52    -92
7      5     13     29    -81    -82    -53    -92
7      6     14     30    -81    -82    -54    -92
7      7     15     31    -81    -82    -55    -92
7      8     16     32    -81    -82    -56    -92
7     57     17     33    -81    -82    -83    -92
7     59     18     34    -81    -82    -84    -92
```

7	61	19	35	-81	-82	-85	-92
7	63	20	36	-81	-82	-86	-92
1	17						
1	18						
1	19						
1	20						
7	58	21	37	-81	-82	-87	-92
7	60	22	38	-81	-82	-88	-92
7	62	23	39	-81	-82	-89	-92
7	64	24	40	-81	-82	-90	-92
1	21						
1	22						
1	23						
1	24						
7	1	9	41	-94	-91	-92	-25
7	2	10	42	-94	-91	-92	-26
7	3	11	43	-94	-91	-92	-27
7	4	12	44	-94	-91	-92	-28
7	5	13	45	-94	-91	-92	-29
7	6	14	46	-94	-91	-92	-30
7	7	15	47	-94	-91	-92	-31
7	8	16	48	-94	-91	-92	-32
5	49	-94	-93	-91	-25		
5	50	-94	-93	-91	-26		
5	51	-94	-93	-91	-27		
5	52	-94	-93	-91	-28		
5	53	-94	-93	-91	-29		
5	54	-94	-93	-91	-30		
5	55	-94	-93	-91	-31		
5	56	-94	-93	-91	-32		
3	57	-82	-83				
3	58	-82	-87				
3	59	-82	-84				
3	60	-82	-88				
3	61	-82	-85				
3	62	-82	-89				
3	63	-82	-86				
3	64	-82	-90				
7	57	17	65	-94	-91	-92	-33
7	58	21	66	-94	-91	-92	-37
7	59	18	67	-94	-91	-92	-34
7	60	22	68	-94	-91	-92	-38
7	61	19	69	-94	-91	-92	-35
7	62	23	70	-94	-91	-92	-39
7	63	20	71	-94	-91	-92	-36
7	64	24	72	-94	-91	-92	-40
7	73	57	83	-94	-93	-91	-33
7	74	58	87	-94	-93	-91	-37
7	75	59	84	-94	-93	-91	-34
7	76	60	88	-94	-93	-91	-38
7	77	61	85	-94	-93	-91	-35
7	78	62	89	-94	-93	-91	-39
7	79	63	86	-94	-93	-91	-36
7	80	64	90	-94	-93	-91	-40
2	-94	-25					
7	81	57	17	33	-82	-83	-92

C.2.31 PROBETAG_DEFINITIONS file

```

PROBETAG_DEFINITIONS      31  4EXAMPLE      5-DEC-1997 10:03
1      -12    10000      0      0      -5000    5000      45 4 16
$P00      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
$P01      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
$P02      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
$P03      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
$P04      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
$P29      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
$P30      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
$P31      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
$P32      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
$P33      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
$P34      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
$P35      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
$P36      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
$P37      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
$P38      1000    2000  -1      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0
      -1      0      -1      0      -1      0      -1      0      -1      0

```

\$P39			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P40			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P41			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P42			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P43			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P44			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P05			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P06			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P07			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P08			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P09			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P10			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P11			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P12			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P13			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P14			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0

\$P15			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P16			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P17			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P18			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P19			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P20			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P21			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P22			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P23			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P24			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P25			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P26			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P27			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
\$P28			1000	2000	-1	-1	0			
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0
	-1	0	-1	0	-1	0	-1	0	-1	0

C.2.32 PROBETAG_ASSIGNMENTS file

```
PROBETAG_ASSIGNMENTS      32      1EXAMPLE      5-DEC-1997 10:03

  1  2  3  4  5  6  7  8  9 10 11 12 13 14 15 16 17 18 19 20
21  0  0  0  0  0  0  0  0  0  0 22 23 24 25 26 27 28 29 30
31 32 33 34 35 36 37 13 12 11 10  9  8  7  6 14 15 16 17 18
19 20 21 13 12 11 10  9  8  7  6 38 39 40 41 42 43 44 45  6
  7  8  9 10 11 12 13 14 15 16 17 18 19 20 21  0  0  0  0  0
  0  0  0  0  0
```

C.2.33 BURSTS file

```
BURSTS      33      1EXAMPLE      5-DEC-1997 10:03
  2          29      1
    1
    28
    30
```

C.2.34 STIMULUS_TEXT file

```
STIMULUS_TEXT      34      1EXAMPLE      5-DEC-1997 10:03
  29
P      4
M 42          Verify DBUS through J1_8 - J1_1
P      11
M 20          Clock U12
P      17
M 39          Verify data through the DBUS
M 20          Clock U12
P      24
M 39          Verify data through the DBUS
M 20          Clock U12
```

C.2.35 NODE_NAMES file

```
NODE_NAMES      35      1EXAMPLE      5-DEC-1997 10:03
 105          26
  80 J1_8.
  81 J1_7.
  82 J1_6.
  83 J1_5.
  84 J1_4.
  85 J1_3.
  86 J1_2.
  87 J1_1.
  88 P1_110.
  89 P1_109.
  90 P1_108.
  91 P1_107.
  92 P1_106.
  93 P1_105.
  94 P1_104.
  95 P1_103.
  96 $L1B
  97 $L0B
  98 $LX
  99 $LZ
 100 $FL1
 101 $FL0
 102 $FLX
```

103 \$PWRON
104 \$L0
105 \$L1

C.2.36 EVENTS_INIT file

```
EVENTS_INIT          36    1EXAMPLE          5-DEC-1997 10:03
    1 -12
OC1K2K3K4K5K6K7K8K9K10K11K12K13K14K15K16K17K18K19K20K21K105H96H104E97E99K100H101
E103E8000A73N74N75N76N77N1783A73H74H75H76H77H8217D73N74N75N76N77N5000C73H74H75H7
6H77H977000C103H1000001@0PR
```

C.2.37 EQUIV_FAULTS file

```
EQUIV_FAULTS          37    1EXAMPLE          5-DEC-1997 10:03
    11      154      159    13
    1 Stuck-at-0
    2 Stuck-at-1
    3 Stuck-at-Z
    4 Stuck-at-X
    5 Open-to-0
    6 Open-to-1
    7 Open-to-Z
    8 Open-to-X
    9 MOS ON
   10 MOS OFF
   11 Shorted nodes
       1      1      6      8<U12>3/1
       2      1      6      8<U12>4/1
       3      1      6      8<U12>7/1
       4      1      6      8<U12>8/1
       5      1      6      9<U12>13/1
       6      1      6      9<U12>14/1
       7      1      6      8<U34>1/1
       8      1      6      9<U12>17/1
       9      1      6      9<U12>18/1
      10      1      1     10<^>P1_50@0
      11      1      2     10<^>P1_50@1
      12      1      1     10<^>P1_49@0
      13      1      2     10<^>P1_49@1
      14      1      1     10<^>P1_48@0
      15      1      2     10<^>P1_48@1
      16      1      1     10<^>P1_52@0
      17      1      2     10<^>P1_52@1
      18      1      1     10<^>P1_51@0
      19      1      2     10<^>P1_51@1
      20      1      1      9<^>J1_8@0
      21      1      2      9<^>J1_8@1
      22      1      1      9<^>J1_7@0
      23      1      2      9<^>J1_7@1
      24      1      1      9<^>J1_6@0
      25      1      2      9<^>J1_6@1
      26      1      1      9<^>J1_5@0
      27      1      2      9<^>J1_5@1
      28      1      1      9<^>J1_4@0
      29      1      2      9<^>J1_4@1
      30      1      1      9<^>J1_3@0
      31      1      2      9<^>J1_3@1
      32      1      1      9<^>J1_2@0
      33      1      2      9<^>J1_2@1
      34      1      1      9<^>J1_1@0
      35      1      2      9<^>J1_1@1
```

36	1	1	11<^>P1_110@0
37	1	2	11<^>P1_110@1
38	1	1	11<^>P1_109@0
39	1	2	11<^>P1_109@1
40	1	1	11<^>P1_108@0
41	1	2	11<^>P1_108@1
42	1	1	11<^>P1_107@0
43	1	2	11<^>P1_107@1
44	1	1	11<^>P1_106@0
45	1	2	11<^>P1_106@1
46	1	1	11<^>P1_105@0
47	1	2	11<^>P1_105@1
48	1	1	11<^>P1_104@0
49	1	2	11<^>P1_104@1
50	1	1	11<^>P1_103@0
51	1	2	11<^>P1_103@1
52	1	6	7<U2>1/1
53	1	6	7<U2>2/1
54	1	6	7<U2>3/1
55	2	6	7<U2>5/1
55	2	6	7<U2>4/1
56	1	1	8<U2>15@0
57	1	2	8<U2>15@1
58	1	6	7<U3>1/1
59	1	6	7<U3>2/1
60	1	6	7<U3>3/1
61	2	6	7<U3>4/1
61	2	6	7<U3>5/1
62	1	1	8<U3>15@0
63	1	2	8<U3>15@1
64	1	6	8<U12>1/1
65	1	6	9<U12>11/1
66	1	1	8<U12>2@0
67	1	2	8<U12>2@1
68	1	1	8<U12>5@0
69	1	2	8<U12>5@1
70	1	1	8<U12>6@0
71	1	2	8<U12>6@1
72	1	1	8<U12>9@0
73	1	2	8<U12>9@1
74	1	1	9<U12>12@0
75	1	2	9<U12>12@1
76	1	1	9<U12>15@0
77	1	2	9<U12>15@1
78	1	1	9<U12>16@0
79	1	2	9<U12>16@1
80	1	1	9<U12>19@0
81	1	2	9<U12>19@1
82	1	6	9<U34>19/1
83	1	1	8<U34>2@0
84	1	2	8<U34>2@1
85	1	1	8<U34>3@0
86	1	2	8<U34>3@1
87	1	1	8<U34>4@0
88	1	2	8<U34>4@1
89	1	1	8<U34>5@0
90	1	2	8<U34>5@1
91	1	1	8<U34>6@0
92	1	2	8<U34>6@1
93	1	1	8<U34>7@0
94	1	2	8<U34>7@1
95	1	1	8<U34>8@0
96	1	2	8<U34>8@1
97	1	1	8<U34>9@0

98	1	2	8<U34>9@1
99	1	1	9<U34>18@0
100	1	2	9<U34>18@1
101	1	1	9<U34>17@0
102	1	2	9<U34>17@1
103	1	1	9<U34>16@0
104	1	2	9<U34>16@1
105	1	1	9<U34>15@0
106	1	2	9<U34>15@1
107	1	1	9<U34>14@0
108	1	2	9<U34>14@1
109	1	1	9<U34>13@0
110	1	2	9<U34>13@1
111	1	1	9<U34>12@0
112	1	2	9<U34>12@1
113	1	1	9<U34>11@0
114	1	2	9<U34>11@1
115	1	6	8<U35>1/1
116	1	1	9<U35>18@0
117	2	2	9<U35>18@1
117	2	6	8<U35>2/1
118	1	6	9<U35>19/1
119	1	1	8<U35>5@0
120	2	6	9<U35>15/1
120	2	2	8<U35>5@1
121	1	1	8<U35>3@0
122	2	2	8<U35>3@1
122	2	6	9<U35>17/1
123	1	1	10<^>J1_8.@0
124	1	2	10<^>J1_8.@1
125	1	1	10<^>J1_7.@0
126	1	2	10<^>J1_7.@1
127	1	1	10<^>J1_6.@0
128	1	2	10<^>J1_6.@1
129	1	1	10<^>J1_5.@0
130	1	2	10<^>J1_5.@1
131	1	1	10<^>J1_4.@0
132	1	2	10<^>J1_4.@1
133	1	1	10<^>J1_3.@0
134	1	2	10<^>J1_3.@1
135	1	1	10<^>J1_2.@0
136	1	2	10<^>J1_2.@1
137	1	1	10<^>J1_1.@0
138	1	2	10<^>J1_1.@1
139	1	1	12<^>P1_110.@0
140	1	2	12<^>P1_110.@1
141	1	1	12<^>P1_109.@0
142	1	2	12<^>P1_109.@1
143	1	1	12<^>P1_108.@0
144	1	2	12<^>P1_108.@1
145	1	1	12<^>P1_107.@0
146	1	2	12<^>P1_107.@1
147	1	1	12<^>P1_106.@0
148	1	2	12<^>P1_106.@1
149	1	1	12<^>P1_105.@0
150	1	2	12<^>P1_105.@1
151	1	1	12<^>P1_104.@0
152	1	2	12<^>P1_104.@1
153	1	1	12<^>P1_103.@0
154	1	2	12<^>P1_103.@1

C.2.38 PROBE_DETECTION file

PROBE_DETECTION			38	1EXAMPLE	5-DEC-1997 10:03				
133	24	154							
1	1	1		10					
1	2	1		12					
1	3	1		14					
1	4	1		16					
1	5	1		18					
1	32	1		56					
1	39	1		16					
1	40	1		62					
1	47	1		18					
1	72	3		14	-115	116			
1	73	1		-115					
1	74	1		-115					
1	75	1		-115					
1	76	1		-118					
1	77	1		-118					
1	78	3		10	-118	119			
1	79	3		12	-118	121			
1	80	2		20	123				
1	81	2		22	125				
1	82	2		24	127				
1	83	2		26	129				
1	84	2		28	131				
1	85	2		30	133				
1	86	2		32	135				
1	87	2		34	137				
1	88	2		36	139				
1	89	2		38	141				
1	90	2		40	143				
1	91	2		42	145				
1	92	2		44	147				
1	93	2		46	149				
1	94	2		48	151				
1	95	2		50	153				
2	-1	1		11					
2	-2	1		13					
2	-3	1		15					
2	-5	1		19					
2	32	1		16					
2	-40	14		11	13	15	19	58	59
61	63	-115		117	-118	120	122		60
2	41	4		11	58	-118	120		
2	42	4		13	59	-118	122		
2	43	1		-118					
2	44	4		15	60	-115	117		
2	-72	2		15	117				
2	-78	2		11	120				
2	-79	2		13	122				
3	80	7		-16	36	-56	-80	-82	99
3	81	7		-16	38	-56	-78	-82	101
3	82	7		-16	40	-56	-76	-82	103
3	83	7		-16	42	-56	-74	-82	105
3	84	7		-16	44	-56	-72	-82	107
3	85	7		-16	46	-56	-70	-82	109
3	86	7		-16	48	-56	-68	-82	111
3	87	7		-16	50	-56	-66	-82	113
4	-80	6		21	37	-81	100	124	140
4	-82	6		25	41	-77	104	128	144
4	-84	6		29	45	-73	108	132	148
4	-86	6		33	49	-69	112	136	152
4	-88	2		37	140				

4	-90	2	41	144					
4	-92	2	45	148					
4	-94	2	49	152					
6	-81	6	23	39	-79	102	126	142	
6	-83	6	27	43	-75	106	130	146	
6	-85	6	31	47	-71	110	134	150	
6	-87	6	35	51	-67	114	138	154	
6	-89	2	39	142					
6	-91	2	43	146					
6	-93	2	47	150					
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C.2.39 F.D._EQUIV_SETS file

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115	117	118	120	122					
94	1	7							

Annex D

(informative)

IEEE List of Participants

The ATPG Subcommittee consisted of the following members who provided significant input toward the development of this standard:

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Jose De La Cruz, *Working Group Chair*
Harold E. Davis, *Secretary*

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Aldo Bernal
Michael Blair
Joanne K. Buckley
Antonius Bunsen
Kenneth M. Butler
Larry D. Carpenter
Alexander Cherfas
Richard Churcher
Tim Coggins
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David Dalbacka
Danny C. Davis
Bernd Dinklage
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William John Taylor
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William A. Whitaker
William W. Young
Jehuda Ziegler

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** Contributing Non-Voting Member

The following individuals are non-voting IEEE-SA Standards Board Liaisons:

William Brenner	Jim Isaak Robert C. Rassa	Oscar Sepp
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The following members of the balloting committee voted on this standard:

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Aldo Bernal	Arthur Hann	William C. Rodriguez
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Kenneth M. Butler	Al Karalius	Howard Savage
Larry D. Carpenter	Larry V. Kirkland	John W. Sheppard
Alexander Cherfas	Gregory A. Maston	William R. Simpson
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Ronald Cox	William P. Neblett	Joseph J. Stanco
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Danny C. Davis	Hans Obermeier	Janette Tuttle
Harold E. Davis	Leslie A. Orlidge	William A. Whitaker
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Bernd Dinklage		Jehuda Ziegler

When the IEEE-SA Standards Board approved this standard on 8 December 1998, it had the following membership:

Richard J. Holleman, <i>Chair</i>	Donald N. Heirman, <i>Vice Chair</i>
Judith Gorman, <i>Secretary</i>	

Satish K. Aggarwal	James H. Gurney	L. Bruce McClung
Clyde R. Camp	Jim D. Isaak	Louis-François Pau
James T. Carlo	Lowell G. Johnson	Ronald C. Petersen
Gary R. Engmann	Robert Kennelly	Gerald H. Peterson
Harold E. Epstein	E. G. "Al" Kiener	John B. Posey
Jay Forster*	Joseph L. Koepfinger*	Gary S. Robinson
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